

# TEST REPORT

## CERTIFICATE OF CONFORMITY

**Standards:** EN 55032:2015 +A11:2020, Class A  
CISPR 32:2015 +Cor 1:2016, Class A  
AS/NZS CISPR 32:2015, Class A  
EN 61000-3-2:2014, Class D  
EN 61000-3-3:2013  
EN 55035:2017 +A11:2020

**Report No.:** CEBDBO-WTW-P21050463

**Model No.:** EVS-2000

**Series Model:** EVS-2XXXXXXXXXXXXXXXXX

("X" can be 0-9, A-Z or blank for marketing purposes)

**Received Date:** May 14, 2021

**Test Date:** May 18 to Jun. 2, 2021

**Issued Date:** Aug. 23, 2021

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**Approved by :** Jim Hsiang , **Date:** Aug. 23, 2021  
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Prepared by : Vivian Cheng / Specialist

Certificate #4327.01

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### Release Control Record

Issue No.	Description	Date Issued
CEBDBO-WTW-P21050463	Original release.	Aug. 23, 2021

## 1 Certification

<b>Product:</b>	Fanless AI Computing System
<b>Brand:</b>	Vecow
<b>Test Model:</b>	EVS-2000
<b>Series Model:</b>	EVS-2XXXXXXXXXXXXXXXXX (“X” can be 0-9, A-Z or blank for marketing purposes)
<b>Sample Status:</b>	Engineering sample
<b>Applicant:</b>	Vecow Co., Ltd.
<b>Test Date:</b>	May 18 to Jun. 2, 2021
<b>Standards:</b>	EN 55032:2015 +A11:2020, Class A CISPR 32:2015 +Cor 1:2016, Class A AS/NZS CISPR 32:2015, Class A EN 61000-3-2:2014, Class D EN 61000-3-3:2013 EN 55035:2017 +A11:2020
<b>Measurement procedure:</b>	EN 61000-4-2:2009 / IEC 61000-4-2:2008 ED. 2.0 EN 61000-4-3:2006 +A1:2008 +A2:2010 / IEC 61000-4-3:2010 ED. 3.2 EN 61000-4-4:2012 / IEC 61000-4-4:2012 ED. 3.0 EN 61000-4-5:2014 +A1:2017 / IEC 61000-4-5:2017 ED. 3.1 EN 61000-4-6:2014+AC:2015 / IEC 61000-4-6:2013 ED. 4.0 EN 61000-4-8:2010 / IEC 61000-4-8:2009 ED. 2.0 EN 61000-4-11:2004 +A1: 2017 / IEC 61000-4-11:2017 ED. 2.1

The above equipment has been tested by **Bureau Veritas Consumer Products Services (H.K.) Ltd., Taoyuan Branch**, and found compliance with the requirement of the above standards. The test record, data evaluation & Equipment Under Test (EUT) configurations represented herein are true and accurate accounts of the measurements of the sample’s EMC characteristics under the conditions specified in this report.

## 2 Summary of Test Results

The test items that the EUT needs to perform according to its interfaces and functions evaluation are as follows:

Standard	Test Item	Result	Remarks
EN 55032	Conducted Emissions from Power Ports	Pass	Minimum passing Class A margin is -11.43 dB at 3.58984 MHz.
EN 55032	Conducted Emissions from Wired Network Ports	Pass	Minimum passing Class A margin is -9.71 dB at 3.58984 MHz.
EN 55032	Radiated Emissions up to 1 GHz	Pass	Minimum passing Class A margin is -4.48 dB at 199.99 MHz
	Radiated Emissions above 1 GHz	Pass	Minimum passing Class A margin is -8.65 dB at 5400.03 MHz.
EN 61000-3-2	Harmonic Current Measurement	Pass	Meets Class D requirements.
EN 61000-3-3	Voltage Fluctuations and Flicker Measurement	Pass	Meets the requirements.
IEC 61000-4-2	Electrostatic Discharges (ESD)	Pass	Performance Criteria B
IEC 61000-4-3	Radio Frequency Electromagnetic Field (RS)	Pass	Performance Criteria A
IEC 61000-4-4	Fast Transients Common Mode (EFT)	Pass	Performance Criteria A
IEC 61000-4-5	Surges	Pass	Performance Criteria A
IEC 61000-4-6	Radio Frequency Common Mode (CS)	Pass	Performance Criteria A
IEC 61000-4-8	Power Frequency Magnetic Field (PFMF)	Pass	Performance Criteria A
IEC 61000-4-11	Voltage Dips and Interruptions (DIP)	Pass	<b>Voltage Dips:</b> < 5 % residual, 0.5 cycle, Performance Criteria A 70% residual, 25 cycles Performance Criteria A <b>Voltage Interruptions:</b> < 5 % residual, 250 cycles Performance Criteria C

Note: Determining compliance based on the results of the compliance measurement, not taking into account measurement instrumentation uncertainty.

## 2.1 Performance Criteria

### General Performance Criteria

These criterions shall be used during the testing of primary functions where no specified in the normative annexes of EN 55035 is applicable.

#### Performance criterion A

The equipment shall continue to operate as intended without operator intervention. No degradation of performance, loss of function or change of operating state is allowed below a performance level specified by the manufacturer when the equipment is used as intended. The performance level may be replaced by a permissible loss of performance. If the minimum performance level or the permissible performance loss is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user may reasonably expect from the equipment if used as intended.

#### Performance criterion B

During the application of the disturbance, degradation of performance is allowed. However, no unintended change of actual operating state or stored data is allowed to persist after the test.

After the test, the equipment shall continue to operate as intended without operator intervention; no degradation of performance or loss of function is allowed, below a performance level specified by the manufacturer, when the equipment is used as intended. The performance level may be replaced by a permissible loss of performance.

If the minimum performance level (or the permissible performance loss), or recovery time, is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user may reasonably expect from the equipment if used as intended.

#### Performance criterion C

Loss of function is allowed, provided the function is self-recoverable, or can be restored by the operation of the controls by the user in accordance with the manufacturer's instructions. A reboot or re-start operation is allowed.

Information stored in non-volatile memory, or protected by a battery backup, shall not be lost.

### **Product Specific Performance criteria for network functions**

Equipment that provides these functions transmits and receives data through ports such as an analogue/digital data port. The networking functions are just like network switching and routing ; data transmission ; supervisory...etc.

The particular performance criteria which are specified in the normative annexes of CISPR 35/ EN 55035 take precedence over the corresponding parts of the general performance criteria.

#### **Performance criterion A**

Where relevant, during the application of the test the network function shall, as a minimum, operate ensuring that:

- established connections shall be maintained throughout the application of the test;
- no change of operational state or corruption of stored data occurs;
- no increase in error rate above the figure defined by the manufacturer occurs. The manufacturer should select the most appropriate performance measurement criteria for the product or system, for example bit error rate, block error rate;
- no request for retry above the figure defined by the manufacturer;
- the data transmission rate does not reduce below the figure defined by the manufacturer;
- no protocol failure occurs;
- other verifications are described in F.3.3.1 of CISPR 35/ EN 55035.

#### **Performance criterion B**

Established connections shall be maintained throughout the test, or shall self-recover in a way and timescale that is imperceptible to the user.

The error rate, request for retry and data transmission rates may be degraded during the application of the test. Degradation of the performance as described in criterion A is permitted, provided that the normal operation of the EUT is self-recoverable to the condition established prior to the application of the test.

Where required, as defined in Clause 5 of CISPR 35/ EN 55035, the acceptable operation of the function shall be verified at the completion of the test as described in Table H.1 of CISPR 35/ EN 55035, by confirming the following:

- the EUT's ability to establish a connection,
- the EUT's ability to clear a connection.

During surge testing disconnection is allowed on the analogue/digital data port being tested.

If the EUT is a supervisory equipment, it shall not impact the normal operation of the network being monitored. In addition, any supervisory functions impacted during the period of the test shall return to the state prior to the test. Elements to consider include: alarms, signalling lamps, printer output, network traffic rates, network monitoring.

#### **Performance criterion C**

Degradation of performance as described in criteria A and B is permitted provided that the normal operation of the EUT is self-recoverable to the condition immediately before the application of the test, or can be restored after the test by the operator.

### **Product Specific Performance Criteria for xDSL**

The particular performance criteria which are specified in the normative annexes of CISPR 35/ EN 55035 take precedence over the corresponding parts of the general performance criteria.

#### **Performance criterion A**

##### **Applicable for the test requirement defined in table clause 2.1 of EN 55035**

During the swept frequency test the established connection shall be maintained throughout the testing and the information transferred without any additional reproducible errors or loss of synchronisation. If a degradation in performance is observed and the system is adaptive, for example has the capability to automatically retrain in the presence of an interfering signal, then for conducted immunity tests only, the following procedure shall be followed:

- a) For each range of interfering frequencies in which degradation in performance is observed, three frequencies (beginning, middle and end) shall be identified.



- b) At each of the frequencies identified in step a), the interfering signal shall be turned on and the system is allowed to retrain.
- c) If the system is able to retrain and then functions correctly for a dwell time of at least 60 seconds without any additional reproducible errors or loss of synchronisation, then the performance level of the system is considered acceptable.
- d) The frequencies identified in step a) and the data rates achieved in step b) shall be recorded in the test report.

**Applicable for the test requirement defined in table clause 2.2 of EN 55035**

It is important that the modems are able to train in the presence of repetitive impulsive noise and minimize disruption to the end-user where a repetitive impulsive noise source starts after the link has synchronized. Therefore the following procedure and performance criteria shall apply.

The manufacturer shall select the class of impulsive noise protection (INP) to be used for the immunity test and should state this information in the technical documentation and in the test report. The maximum delay shall be set to 8 ms.

**In the absence of impulsive noise:** The modem shall operate without retraining at its target noise margin with a bit rate value depending on the line attenuation and the stationary noise being present on the line. (The actual value will be between the minimum and maximum bit rate values programmed in the port).

The impulsive noise source shall then be applied at the required test level.

**With the impulsive noise applied:** The modem shall operate without retraining and without SES at the bit rate established prior to the application of the impulsive noise. No extra CRC errors shall occur due to the impulsive noise.

After the test, the noise margin value shall return to the target noise margin.

**Performance criterion B**

**Applicable for the test requirement defined in table clause 2.3 of EN 55035**

Modems shall withstand the occurrence of isolated impulsive noise events. The performance criteria defined in below Table shall be applied.

Impulse duration (ms)	Performance criteria
0.24	The application of the impulse shall not cause the xDSL link to lose synchronisation. No CRC errors are permitted.
10	The application of the 5 impulses shall result in less than 75 CRC errors and shall not cause the link to lose synchronisation.
300	The application of the impulse shall not cause the xDSL link to lose synchronisation.

**Applicable for the test requirements defined in table clauses 2.5 and 4.5 of EN 55035**

For application of this test to the xDSL port, a repetition rate of 100 kHz (burst length 0.75 ms) shall be used. Degradation of the performance as described in criterion A is permitted in that errors are acceptable during the application of the test. However the application of the test shall not cause the system to lose the established connection or re-train. At the cessation of the test the system shall operate in the condition established prior to the application of the test without user intervention.

After the application of the EFT/B tests to the xDSL or AC mains port, the CRC error count shall not have increased by more than 600 when compared to the count prior to the application of the test.

**Performance criterion C**

Degradation of the performance as described in criteria A and B is permitted provided that the normal operation of the EUT is self-recoverable to the condition established prior to application of the test or can be restored after the test by the operator.

## 2.2 Measurement Uncertainty

Where relevant, the following measurement uncertainty levels have been estimated for tests performed on the EUT as specified in CISPR 16-4-2:

Measurement	Expanded Uncertainty (k=2) ( $\pm$ )	Maximum allowable uncertainty ( $\pm$ )
Conducted Emissions from Power Ports	3.00 dB	3.4 dB ( $U_{\text{CISPR}}$ )
Conducted Emissions from Wired Network Ports	3.94 dB	5.0 dB ( $U_{\text{CISPR}}$ )
Radiated Emissions up to 1 GHz	4.30 dB	6.3 dB ( $U_{\text{CISPR}}$ )
Radiated Emissions above 1 GHz	4.96 dB	5.2 dB ( $U_{\text{CISPR}}$ )

The other instruments specified are routine verified to remain within the calibrated levels, no measurement uncertainty is required to be calculated.

## 2.3 Supplementary Information

There is not any deviation from the test standards for the test method, and no modifications required for compliance.

### 3 General Information

#### 3.1 Description of EUT

Product	Fanless AI Computing System
Brand	Vecow
Test Model	EVS-2000
Series Model	EVS-2XXXXXXXXXXXXXXXXX ("X" can be 0-9, A-Z or blank for marketing purposes)
Model Difference	For marketing purpose
Sample Status	Engineering sample
Operating Software	Windows 10, Burnintest
Power Supply Rating	DC from Adapter
Accessory Device	N/A
Data Cable Supplied	N/A

Note:

The EUT uses following adapter.

Brand	MW
Model	GST280A24-C6P
Input Power	100-240Vac, 4.5A, 50/60Hz
Output Power	24Vdc, 41.67A, 280W
Power Line	AC 3Pin Non-shielded DC cable (1.5m) with one ferrite core.

#### 3.2 Primary Clock Frequencies of Internal Source

The highest frequency generated or used within the EUT or on which the EUT operates or tunes is 2.8GHz, provided by Vecow Co., Ltd., for detailed internal source, please refer to the manufacturer's specifications.

#### 3.3 Features of EUT

1. The tests reported herein were performed according to the method specified by Vecow Co., Ltd., for detailed feature description, please refer to the manufacturer's specifications or user's manual.
2. The EUT configured with the following key components:

Components	Brand	Model	Specification
CPU	Intel	i9-10900E	2.8GHz
GPU	NVIDIA	GeForce RTX 2080	-
RAM	Kingston	KVR21S15S8/8 1.2V	DDR4 2666 8GB
SSD	Innodisk	-	2.5" SATA SSD 3ME4 128GB

### 3.4 Operating Modes of EUT and Determination of Worst Case Operating Mode

1. The EUT was pre-tested under operating and standby condition and the worst emission level was found under **operating condition**.
2. The EUT consumed power from AC adapter, which designed with AC power supply of 100-240Vac, 50/60Hz.  
For radiated emission evaluation, 230Vac/ 50Hz & 110Vac/ 60Hz had been covered during the pre-test. The worst radiated emission data was found at **110Vac/ 60Hz** and recorded in the applied test report.
3. EUT has been pre-tested under following test modes, and test **mode 2** was the worst case for final test.

Mode	Test Condition
1	Display* 5: 3840*2160, 60Hz + DVI: 1920*1200, 60Hz
2	Display* 5: 3840*2160, 60Hz + D-Sub: 1920*1200, 60Hz

4. Test modes are presented in the report as below.

Mode	Test Condition	Input Power
Conducted emission test		
2	Display* 5: 3840*2160, 60Hz + D-Sub: 1920*1200, 60Hz	230Vac/ 50Hz & 110Vac/ 60Hz
Conducted Emissions from Wired network ports test		
2A	Display* 5: 3840*2160, 60Hz + D-Sub: 1920*1200, 60Hz – LAN por 1 (Speed: 1Gbps)	230Vac/ 50Hz
2B	Display* 5: 3840*2160, 60Hz + D-Sub: 1920*1200, 60Hz – LAN por 2 (Speed: 1Gbps)	
The idle mode of conducted emission test at telecom port was pre-tested based on the worst case of link mode. Due to emissions of idle mode being very low compared to link mode, only the link mode data were presented in the test report.		
Radiated emission test		
2	Display* 5: 3840*2160, 60Hz + D-Sub: 1920*1200, 60Hz	110Vac/ 60Hz
Harmonics, Flicker, Immunity tests		
2	Display* 5: 3840*2160, 60Hz + D-Sub: 1920*1200, 60Hz	230Vac/ 50Hz

### 3.5 Test Program Used and Operation Descriptions

#### Emission tests (Harmonics & Flicker excluded):

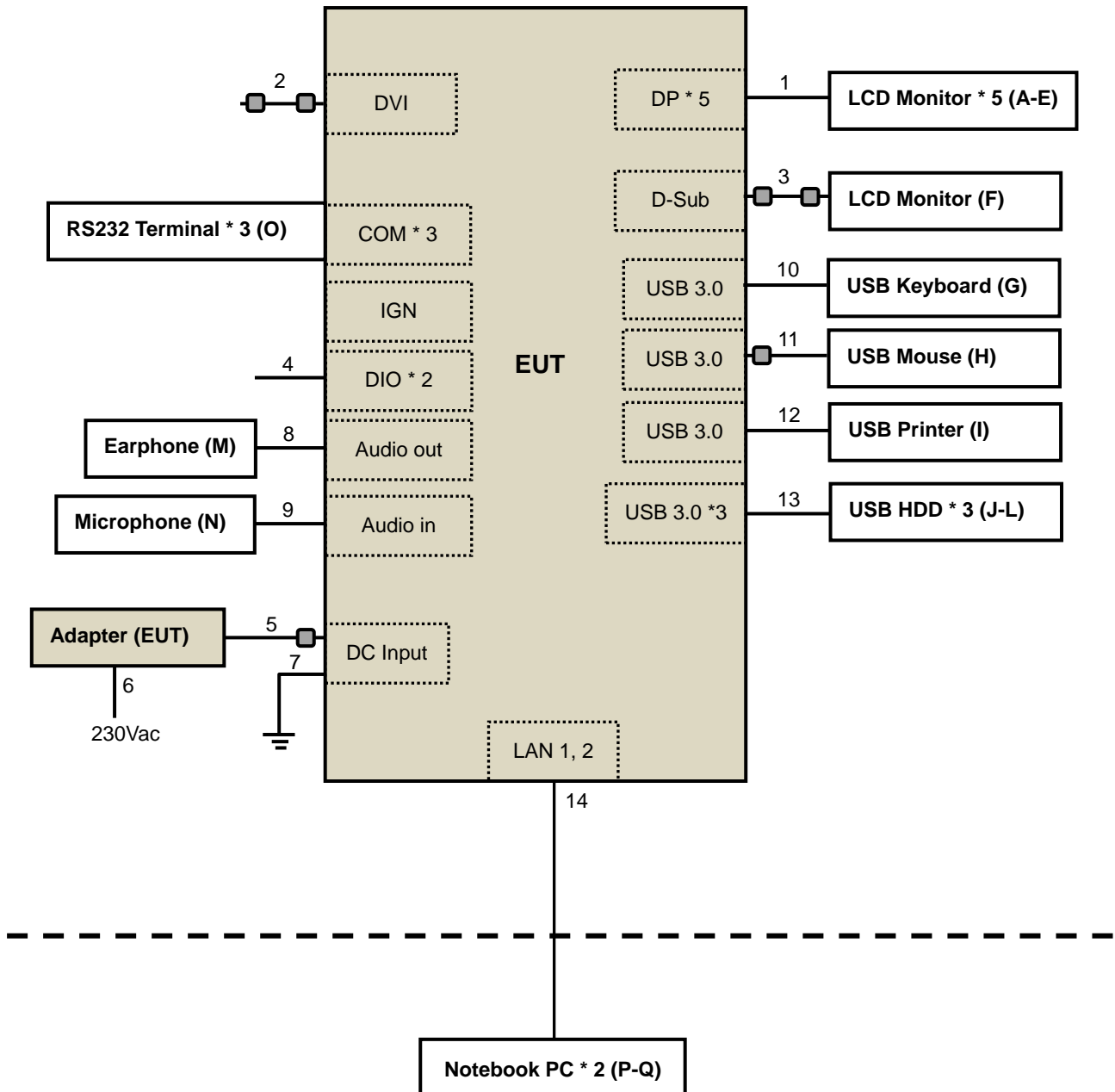
- a. Turned on the power of all equipment.
- b. EUT ran a test program to enable all functions.
- c. EUT read and wrote messages from/to SSD and ext. HDDs.
- d. EUT sent and received messages to/from Notebook PCs (kept in a remote area) via two STP LAN cables (10m each).
- e. EUT sent “color bars with moving element” messages to ext. LCD Monitors. Then they displayed “color bars with moving element” messages on their screens simultaneously.
- f. EUT sent messages to printer and printer printed them out.
- g. EUT sent “1kHz” audio signal to earphone.
- h. Steps c-g were repeated.

#### Harmonics, Flicker, Immunity tests:

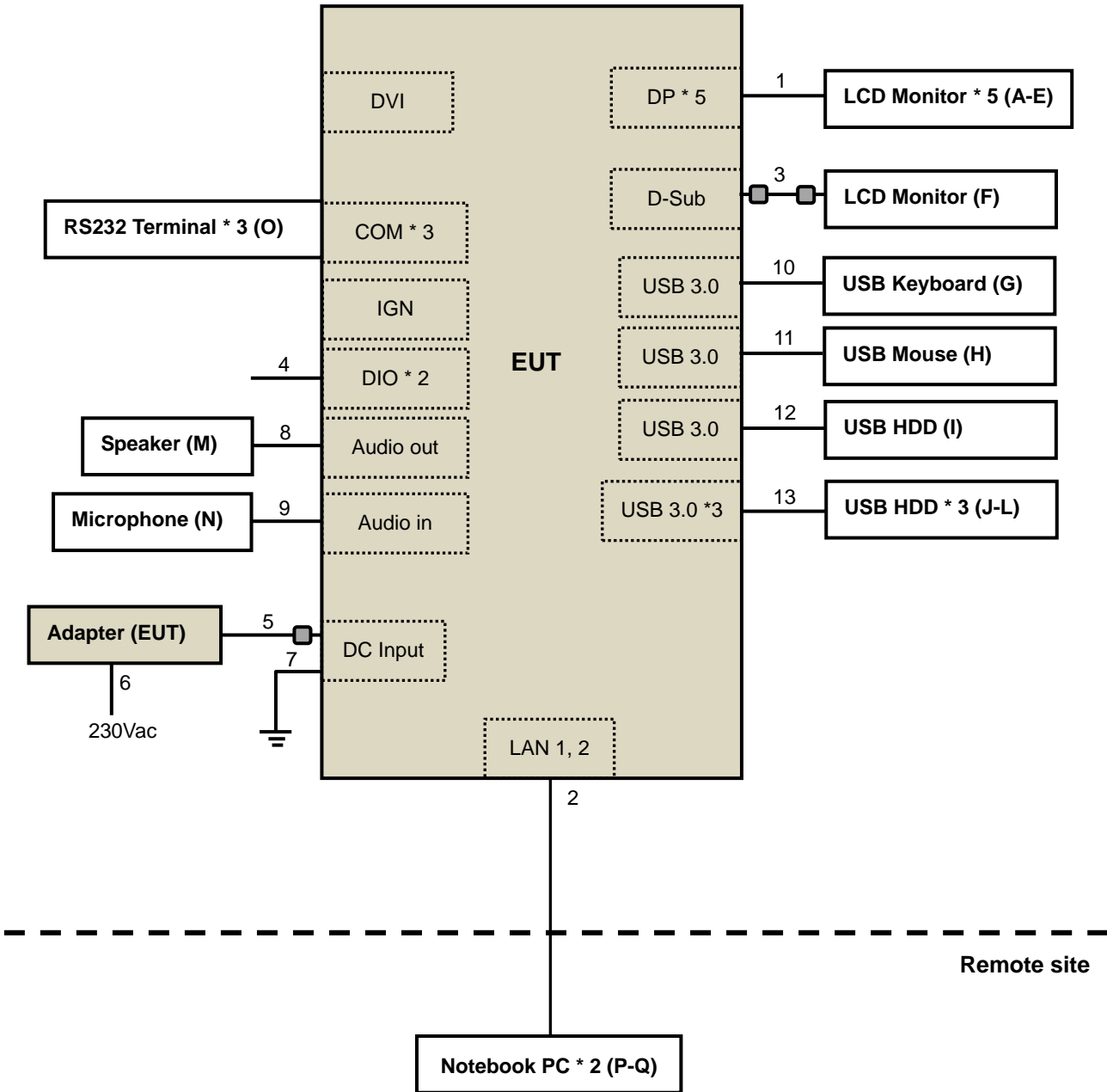
- a. Turned on the power of all equipment.
- b. EUT ran a test program to enable all functions.
- c. EUT read and wrote messages from/to SSD and ext. HDDs.
- d. EUT sent and received messages to/from Notebook PCs (kept in a remote area) via two STP LAN cables (10m each).
- e. EUT sent “color bars” messages to ext. LCD Monitors. Then they displayed “color bars” messages on their screens simultaneously.
- f. EUT sent audio signal to speaker.
- g. Steps c-f were repeated.

### 3.6 Connection Diagram of EUT and Peripheral Devices

Emission tests (Harmonics & Flicker excluded):



Harmonics & Flicker & Immunity tests:



### 3.7 Configuration of Peripheral Devices and Cable Connections

Emission tests (Harmonics & Flicker excluded):

ID	Product	Brand	Model No.	Serial No.	FCC ID	Remarks
A.	LCD MONITOR	ASUS	VG289Q	M1LMTF385740	NA	Provided by Lab
B.	LCD MONITOR	ASUS	VG289Q	M1LMTF385742	NA	Provided by Lab
C.	LCD MONITOR	ASUS	VG289Q	M1LMTF385752	NA	Provided by Lab
D.	LCD MONITOR	ASUS	VG289Q	M1LMTF385832	NA	Provided by Lab
E.	LCD MONITOR	ASUS	MX27U	K1LMRS022996	NA	Provided by Lab
F.	LCD MONITOR	DELL	U2410	CN082WXD728720C C0HLL	FCC DoC Approved	Provided by Lab
G.	USB Keyboard	Dell	KB216t	CN-0W33XP-LO300- 7CL-1909	NA	Provided by Lab
H.	USB Mouse	Microsoft	1113	9170528318308	FCC DoC Approved	Provided by Lab
I.	USB Printer	HP	HP Officejet Pro 251dw	CN55FCV012	FCC DoC Approved	Provided by Lab
J.	USB 3.1 Hard Disk	Transcend	SSD220S	SK21D1718X00A7	FCC DoC Approved	Provided by Lab
K.	USB 3.1 Hard Disk	Transcend	SSD220S	SK21D1718X008N	FCC DoC Approved	Provided by Lab
L.	USB-C Hard Disk	G-DRIVE	0G04878	620XJ6RW	FCC DoC Approved	Provided by Lab
M.	EARPHONE	PHILIPS	SBC HL145	N/A	NA	Provided by Lab
N.	MICROPHONE	Labtec	mic-333	N/A	NA	Provided by Lab
O.	RS232 Terminal* 3	NA	NA	NA	NA	Supplied by client
P.	Notebook PC	LENOVO	T480	PF1EZSAW	NA	Provided by Lab
Q.	Notebook PC	LENOVO	T480	PF1EZSA2	NA	Provided by Lab

Note:

1. All power cords of the above support units are non-shielded (1.8m).
2. Items P-Q acted as communication partners to transfer data.

ID	Cable Descriptions	Qty.	Length (m)	Shielding (Yes/No)	Cores (Qty.)	Remarks
1.	DP cable	5	1.8	Y	0	Provided by Lab
2.	DVI cable	1	1.8	Y	2	Provided by Lab
3.	D-Sub cable	1	1.8	Y	2	Provided by Lab
4.	Signal cable	2	0.3	N	0	Provided by Lab
5.	DC power cable	1	1.5	N	1	Supplied by client
6.	AC power cable	1	1.5	N	0	Supplied by client
7.	GND cable	1	1.6	N	0	Provided by Lab
8.	Audio cable	1	2.0	N	0	Provided by Lab
9.	Audio cable	1	1.5	N	0	Provided by Lab
10.	USB cable	1	1.8	Y	0	Provided by Lab
11.	USB cable	1	1.8	Y	1	Provided by Lab
12.	USB cable	1	1.5	Y	0	Provided by Lab
13.	USB cable	3	1.0	Y	0	Provided by Lab
14.	LAN cable	2	10	Y	0	Provided by Lab (RJ45, Cat.5e)

Note: The core(s) is(are) originally attached to the cable(s).



**Harmonics, Flicker, Immunity tests:**

ID	Product	Brand	Model No.	Serial No.	FCC ID	Remarks
A.	LCD MONITOR	DELL	U2412M	CN-07N2FG-TV100-9 5R-05KB	NA	Provided by Lab
B.	LCD MONITOR	DELL	P2415Qb	CN-OGTTPW-74261- 662-OAGL	NA	Provided by Lab
C.	LCD MONITOR	DELL	P2415Qb	CN-OGTTPW-74261- 662-OAAL	NA	Provided by Lab
D.	LCD MONITOR	DELL	P2418HZM	CN-079XVV-TV200-8 BG-00NT	NA	Provided by Lab
E.	LCD MONITOR	DELL	U2412M	CN-07N2FG-TV100-9 75-090U	NA	Provided by Lab
F.	LCD MONITOR	DELL	S2316Hc	NA	NA	Provided by Lab
G.	USB Keyboard	HP	KU1516	NA	NA	Provided by Lab
H.	USB Mouse	HP	M-UAE96	F93A90AN3V42GQ5	FCC DoC Approved	Provided by Lab
I.	USB 3.1 Hard Disk	WD	MY PASSPORT SSD	180887421116	NA	Provided by Lab
J.	USB 3.1 Hard Disk	WD	MY PASSPORT SSD	180887420071	NA	Provided by Lab
K.	USB 3.1 Hard Disk	WD	MY PASSPORT SSD	180887421083	NA	Provided by Lab
L.	USB 3.1 Hard Disk	WD	MY PASSPORT SSD	180887421404	NA	Provided by Lab
M.	Speaker	NA	NA	NA	NA	Provided by Lab
N.	MICROPHONE	NA	NA	NA	NA	Provided by Lab
O.	RS232 Terminal* 3	NA	NA	NA	NA	Supplied by client
P.	Notebook PC	Lenovo	T470	PF-0QW0NQ	NA	Provided by Lab
Q.	Notebook PC	Lenovo	L460	PF0PLH DU	NA	Provided by Lab

**Note:**

1. All power cords of the above support units are non-shielded (1.8m).
2. Items P-Q acted as communication partners to transfer data.

ID	Cable Descriptions	Qty.	Length (m)	Shielding (Yes/No)	Cores (Qty.)	Remarks
1.	DP cable	5	1.8	Y	0	Provided by Lab
2.	LAN cable	2	10	Y	0	Provided by Lab (RJ45, Cat.5e)
3.	D-Sub cable	1	1.8	Y	2	Provided by Lab
4.	Signal cable	2	0.3	N	0	Provided by Lab
5.	DC power cable	1	1.5	N	1	Supplied by client
6.	AC power cable	1	1.5	N	0	Supplied by client
7.	GND cable	1	1.0	N	0	Provided by Lab
8.	Audio cable	1	1.0	N	0	Provided by Lab
9.	Audio cable	1	1.0	N	0	Provided by Lab
10.	USB cable	1	1.8	Y	0	Provided by Lab
11.	USB cable	1	1.8	Y	0	Provided by Lab
12.	USB cable	1	0.6	Y	0	Provided by Lab
13.	USB cable	3	0.3	Y	0	Provided by Lab

Note: The core(s) is(are) originally attached to the cable(s).

## 4 Test Instruments

The calibration interval of the all test instruments are 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

### 4.1 Conducted Emissions from Power Ports

Description & Manufacturer	Model No.	Serial No.	Cal. Date	Cal. Due
ROHDE &SCHWARZ TEST RECEIVER	ESCS 30	838251/021	Nov. 3, 2020	Nov. 2, 2021
ROHDE & SCHWARZ Artificial Mains Network (For EUT)	ENV216	101196	Apr. 26, 2021	Apr. 25, 2022
LISN With Adapter(for EUT)	101196	NA	Apr. 26, 2021	Apr. 25, 2022
EMCO L.I.S.N. (For peripherals)	3825/2	9504-2359	Jul. 28, 2020	Jul. 27, 2021
SCHWARZBECK Artificial Mains Network (For EUT)	NNLK8129	8129229	May 20, 2021	May 19, 2022
SCHWARZBECK Artificial Mains Network (for EUT)	NNLK 8121	8121-808	Apr. 18, 2021	Apr. 17, 2022
Software	Cond_V7.3.7.4	NA	NA	NA
RF cable (JYEBAO) With10dB PAD	5D-FB	Cable-C03-01	Sep. 16, 2020	Sep. 15, 2021
LYNICS Terminator (For EMCO LISN)	0900510	E1-01-300	Jan. 27, 2021	Jan. 26, 2022
LYNICS Terminator (For EMCO LISN)	0900510	E1-01-301	Jan. 27, 2021	Jan. 26, 2022

- Note: 1. The test was performed in Shielded Room No. 3. (Conduction 3)  
 2. The VCCI Site Registration No. C-10274.  
 3. Tested Date: May 24, 2021

### 4.2 Conducted Emissions from Wired Network Ports

Description & Manufacturer	Model No.	Serial No.	Cal. Date	Cal. Due
ROHDE & SCHWARZ TEST RECEIVER	ESCS 30	838251/021	Nov. 3, 2020	Nov. 2, 2021
ROHDE & SCHWARZ Artificial Mains Network (For EUT)	ENV216	101196	Apr. 26, 2021	Apr. 25, 2022
LISN With Adapter (for EUT)	101196	NA	Apr. 26, 2021	Apr. 25, 2022
EMCO L.I.S.N. (For peripherals)	3825/2	9504-2359	Jul. 28, 2020	Jul. 27, 2021
SCHWARZBECK Artificial Mains Network (For EUT)	NNLK8129	8129229	May 20, 2021	May 19, 2022
SCHWARZBECK Artificial Mains Network (for EUT)	NNLK 8121	8121-808	Apr. 18, 2021	Apr. 17, 2022
Software	Cond_V7.3.7.4	NA	NA	NA
Software	ISN_V7.3.7.4	NA	NA	NA
RF cable (JYEBAO)	5D-FB	Cable-C03.0 1	Sep. 16, 2020	Sep. 15, 2021
LYNICS Terminator (For EMCO LISN)	0900510	E1-01-300	Jan. 27, 2021	Jan. 26, 2022
LYNICS Terminator (For EMCO LISN)	0900510	E1-01-301	Jan. 27, 2021	Jan. 26, 2022
TESEQ ISN	ISN ST08	41212	Aug. 3, 2020	Aug. 2, 2021

- Note: 1. The test was performed in Shielded Room No. 3. (ISN 3)  
 2. The VCCI Site Registration No. T-11651.  
 3. Tested Date: May 24, 2021

#### 4.3 Radiated Emissions up to 1 GHz

Description & Manufacturer	Model No.	Serial No.	Cal. Date	Cal. Due
ROHDE & SCHWARZ TEST RECEIVER	ESCS 30	100292	Aug. 26, 2020	Aug. 25, 2021
Schwarzbeck Bilog Antenna	VULB9168	9168-303	Nov. 5, 2020	Nov. 4, 2021
Agilent Preamplifier	8447D	2944A08119	Feb. 18, 2021	Feb. 17, 2022
ADT. Turn Table	TT100	0205	NA	NA
ADT. Tower	AT100	0205	NA	NA
Software	Radiated_V7.6.15.9.5	NA	NA	NA
ADT RF Switches BOX	EMH-011	1001	Oct. 23, 2020	Oct. 22, 2021
Pacific RF cable With 5dB PAD	8D	CABLE-ST2-01	Oct. 23, 2020	Oct. 22, 2021

Note: 1. The test was performed in Open Site No. 2.  
2. The VCCI Site Registration No. R-10237.  
3. Tested Date: May 27, 2021

#### 4.4 Radiated Emissions above 1 GHz

Description & Manufacturer	Model No.	Serial No.	Cal. Date	Cal. Due
Agilent Spectrum	E4446A	MY51100009	Jun. 23, 2020	Jun. 22, 2021
R&S Test Receiver	ESR3	102412	Jan. 29, 2021	Jan. 28, 2022
EMCI Preamplifier	EMC0126545	980076	Feb. 19, 2021	Feb. 18, 2022
MITEQ Preamplifier	AMF-6F-260400-33-8P	892164	Feb. 19, 2021	Feb. 18, 2022
EMCI Preamplifier	EMC184045B	980235	Feb. 19, 2021	Feb. 18, 2022
ETS Preamplifier	3117-PA	00215857	Nov. 23, 2020	Nov. 22, 2021
Schwarzbeck Horn Antenna	BBHA-9170	212	Nov. 22, 2020	Nov. 21, 2021
EMCO Horn Antenna	3115	9312-4192	Nov. 22, 2020	Nov. 21, 2021
Max Full. Turn Table & Tower	MF7802	MF780208103	NA	NA
Software	Radiated_V8.7.08	NA	NA	NA
SUHNER RF cable With 3/4dB PAD	SF102	Cable-CH7-3.6m	Jul. 9, 2020	Jul. 8, 2021
MICRO-TRONICS Notch filter	BRC50703-01	010	May 29, 2020	May 28, 2021
MICRO-TRONICS Band Pass Filter	BRM17690	005	May 29, 2020	May 28, 2021

Note: 1. The 3dB beamwidth of the horn antenna is minimum 40 degree (or  $w = 2.18m$  at 3m distance) for 1~6 GHz.  
2. The test was performed in Chamber No. 7.  
3. The VCCI Site Registration No. G-10039  
4. Tested Date: May 18, 2021

#### 4.5 Harmonics Current Measurement

Description & Manufacturer	Model No.	Serial No.	Cal. Date	Cal. Due
Teseq Harmonics - Flicker Test System	Proflin 2105	32A00983 & 1639A01863	Sep. 16, 2020	Sep. 15, 2021
Software	CTS 4	NA	NA	NA

Note: 1. The test was performed in EMS Room No. 1.  
 2. Tested Date: May 31, 2021

#### 4.6 Voltage Fluctuations and Flicker Measurement

Description & Manufacturer	Model No.	Serial No.	Cal. Date	Cal. Due
Teseq Harmonics - Flicker Test System	Proflin 2105	32A00983 & 1639A01863	Sep. 16, 2020	Sep. 15, 2021
Software	CTS 4	NA	NA	NA

Note: 1. The test was performed in EMS Room No. 1.  
 2. Tested Date: May 31, 2021

#### 4.7 Electrostatic Discharge (ESD)

Description & Manufacturer	Model No.	Serial No.	Cal. Date	Cal. Due
KeyTek, ESD Simulator	MZ-15/EC	0504259	Nov. 6, 2020	Nov. 5, 2021

Note: 1. The test was performed in ESD Room No. 1.  
 2. Tested Date: Jun. 2, 2021

#### 4.8 Radio Frequency Electromagnetic Field (RS)

Description & Manufacturer	Model No.	Serial No.	Cal. Date	Cal. Due
R&S Signal Generator	SMJ100A	101925	Sep. 2, 2020	Sep. 1, 2021
BONN RF Amplifier	BSA 0125-800	1912556	NA	NA
TESTQ Amplifier	CBA 1G-275	T44344	NA	NA
AR RF Amplifier	35S4G8AM4	0326094	NA	NA
AR RF Amplifier	100S1G4M3	0329249	NA	NA
AR Controller	SC1000M3	305910	NA	NA
ARLog-Periodic Antenna	AT6080	0329465	NA	NA
BOONTON RF Voltage Meter	4232A	10180	May 24, 2021	May 23, 2022
BOONTON Power Sensor	51011-EMC	34152	May 24, 2021	May 23, 2022
BOONTON Power Sensor	51011-EMC	34153	May 24, 2021	May 23, 2022
EMCO BiconiLog Antenna	3141	1001	NA	NA
ARHigh Gain Antenna	AT4010	0329800	NA	NA
SchwarzbeckLOG ANTENNA	Stlp 9149	9149-260	NA	NA
CHANCE MOST Full Anechoic Chamber (9x5x3m)	Chance Most	RS-002	Feb. 4, 2021	Feb. 3, 2022
Software	RS_V7.6	NA	NA	NA

Note: 1. The test was performed in RS Room No.2.  
2. Tested Date: May 31, 2021

#### 4.9 Fast Transients Common Mode (EFT)

Description & Manufacturer	Model No.	Serial No.	Cal. Date	Cal. Due
Haefely, EFT Generator	PEFT 4010	154954	Apr. 7, 2021	Apr. 6, 2022
Haefely, Capacitive Clamp	IP4A	155173	Apr. 7, 2021	Apr. 6, 2022

Note: 1. The test was performed in EFT Room.  
2. Tested Date: May 26, 2021

#### 4.10 Surge

Description & Manufacturer	Model No.	Serial No.	Cal. Date	Cal. Due
TESEQ, Surge Simulator	NSG 3060	1572	Apr. 30, 2021	Apr. 29, 2022
Coupling Decoupling Network	CDN-UTP8	045	Aug. 18, 2020	Aug. 17, 2021
TESEQ Coupling Decoupling Network	CDN HSS-2	41009	Apr. 30, 2021	Apr. 29, 2022
TESEQ Coupling Decoupling Network	CDN 118-T8	40386	Sep. 8, 2020	Sep. 7, 2021
TESEQ CDN for Unshielded Unsymmetrical Signal & Data Lines	CDN117	40144	Sep. 8, 2020	Sep. 7, 2021

Note: 1. The test was performed in EMS Room No. 2.  
2. Tested Date: Jun. 1, 2021

#### 4.11 Radio Frequency Common Mode (CS)

Description & Manufacturer	Model No.	Serial No.	Cal. Date	Cal. Due
ROHDE & SCHWARZ Signal Generator	SML03	101801	Jan. 13, 2021	Jan. 12, 2022
Digital Sweep Function Generator	8120	984801	NA	NA
AR Power Amplifier	75A250AM1	306331	NA	NA
FCC Coupling Decoupling Network	FCC-801-M2-16A	01047	Jun. 18, 2020	Jun. 17, 2021
FISCHER CUSTOM COMMUNICATIONS EM Injection Clamp	F-203I-23mm	455	NA	NA
FISCHER CUSTOM COMMUNICATIONS Current Injection Clamp	F-120-9A	361	Jul. 30, 2020	Jul. 29, 2021
B&K Ear Simulator	4185	2553594	NA	NA
EM TEST Coupling Decoupling Network	CDN M1/32A	306508	Jun. 18, 2020	Jun. 17, 2021
TESEQ Coupling Decoupling Network	CDN T800	34428	Jun. 18, 2020	Jun. 17, 2021
TESEQ Coupling Decoupling Network	CDN T800	29459	Jun. 18, 2020	Jun. 17, 2021
TESEQ Coupling Decoupling Network	CDN T8-230	56641	Feb. 25, 2021	Feb. 24, 2022
TESEQ Coupling Decoupling Network	CDN T8-230	56642	Feb. 25, 2021	Feb. 24, 2022
R&S Power Sensor	NRV-Z5	837878/039	Nov. 10, 2020	Nov. 9, 2021
R&S Power Meter	NRVD	837794/040	Nov. 10, 2020	Nov. 9, 2021
TESEQ Coupling Decoupling Network	CDN M232	37702	Jun. 18, 2020	Jun. 17, 2021
TESEQ Coupling Decoupling Network	CDN M332	41258	Jun. 18, 2020	Jun. 17, 2021
TESEQ Coupling Decoupling Network	CDN M332	41256	Jun. 18, 2020	Jun. 17, 2021
TESEQ Coupling Decoupling Network	CDN T8-10	40376	Jun. 18, 2020	Jun. 17, 2021
TESEQ Coupling Decoupling Network	CDN T8-230	56643	Feb. 25, 2021	Feb. 24, 2022
TESEQ Coupling Decoupling Network	CDN S200	53490	May 26, 2021	May 25, 2022
TESEQ Coupling Decoupling Network	CDN S400	52115	Jun. 18, 2020	Jun. 17, 2021
TESEQ Coupling Decoupling Network	CDN T400A	49918	Feb. 25, 2021	Feb. 24, 2022
FCC Coupling Decoupling Network	FCC-801-M5-50A	100018	Jan. 19, 2021	Jan. 18, 2022
TESEQ Coupling Decoupling Network	CDN T2A-10	54942	Feb. 25, 2021	Feb. 24, 2022
TESEQ Coupling Decoupling Network	CDN S751A	56435	Feb. 25, 2021	Feb. 24, 2022
TESEQ Coupling Decoupling Network	CDN ST08A	56527	Feb. 25, 2021	Feb. 24, 2022
TESEQ Coupling Decoupling Network	CDN ST08A	56525	Feb. 25, 2021	Feb. 24, 2022
TESEQ Coupling Decoupling Network	CDN M432S	56519	Feb. 25, 2021	Feb. 24, 2022
TESEQ Coupling Decoupling Network	CDN S751A	56436	Feb. 25, 2021	Feb. 24, 2022
Software	CS_V7.4.2	NA	NA	NA

Note: 1. The test was performed in CS Room No. 1.  
 2. Tested Date: Jun. 1, 2021

#### 4.12 Power Frequency Magnetic Field (PFMF)

Description & Manufacturer	Model No.	Serial No.	Cal. Date	Cal. Due
HAEFELY Magnetic Field Tester	MAG 100	083794-06	NA	NA
F.W. Bell Magnetic Field Meter	4190	0743043	Apr. 8, 2021	Apr. 7, 2022

Note: 1. The test was performed in EMS Room No. 1  
2. Tested Date: Jun. 1, 2021

#### 4.13 Voltage Dips and Interruptions (DIP)

Description & Manufacturer	Model No.	Serial No.	Cal. Date	Cal. Due
Teseq Immunity Test System	Proflin 2105	1632A00983 & 1639A01863	Jun. 9, 2020	Jun. 8, 2021
Software	WIN2120	NA	NA	NA

Note: 1. The test was performed in EMS Room No. 1.  
2. Tested Date: May 31, 2021

## 5 Limits of Test Items

For equipment intended to be used exclusively in an industrial environment or a telecommunication centre the class A limits can be used.

### 5.1 Conducted Emissions from Power Ports

For AC mains power input/output Port

Frequency (MHz)	Class A (dB $\mu$ V)		Class B (dB $\mu$ V)	
	Quasi-peak	Average	Quasi-peak	Average
0.15 - 0.5	79	66	66 - 56	56 - 46
0.50 - 5.0	73	60	56	46
5.0 - 30.0	73	60	60	50

Notes: 1. The lower limit shall apply at the transition frequencies.  
 2. The limit decreases linearly with the logarithm of the frequency in the range of 0.15 to 0.50 MHz.

### 5.2 Conducted Emissions from Wired Network Ports

Class A					
Frequency (MHz)	Coupling Device	Voltage Limit (dBuV)		Current limits (dBuA)	
		Quasi-peak	Average	Quasi-peak	Average
0.15 - 0.5	AAN	97 - 87	84 - 74	-	-
0.5 - 30		87	74	-	-
0.15 - 0.5	CVP and Current probe	97 - 87	84 - 74	53 - 43	40 - 30
0.5 - 30		87	74	43	30
0.15 - 0.5	Current Probe	-	-	53-43	40 - 30
0.5 - 30		-	-	43	30
Class B					
Frequency (MHz)	Coupling Device	Voltage Limit (dBuV)		Current limits (dBuA)	
		Quasi-peak	Average	Quasi-peak	Average
0.15-0.5	AAN	84 - 74	74 - 64	-	-
0.5-30		74	64	-	-
0.15-0.5	CVP and Current probe	84 - 74	74 - 64	40 - 30	30 - 20
0.5-30		74	64	30	20
0.15-0.5	Current Probe	-	-	40 - 30	30 - 20
0.5-30		-	-	30	20

Note: The limits decrease linearly with the logarithm of the frequency in the range 0.15 MHz to 0.5 MHz.

### 5.3 Radiated Emissions up to 1 GHz

Frequency (MHz)	Class A (dBuV/m)		Class B (dBuV/m)	
	at 3m	at 10m	at 3m	at 10m
30 - 230	50	40	40	30
230 - 1000	57	47	47	37

Notes: 1. The lower limit shall apply at the transition frequencies.  
 2. Emission level (dBuV/m) = 20 log Emission level (uV/m).  
 3. All emanations from a class A/B digital device or system, including any network of conductors and apparatus connected thereto, shall not exceed the level of field strengths specified above.



#### 5.4 Radiated Emissions above 1 GHz

Frequency (GHz)	Class A (dBuV/m) (at 3m)		Class B (dBuV/m) (at 3m)	
	Average	Peak	Average	Peak
1 to 3	56	76	50	70
3 to 6	60	80	54	74

- Notes:
1. The lower limit shall apply at the transition frequencies.
  2. Emission level (dBuV/m) = 20 log Emission level (uV/m).
  3. All emanations from a class A/B digital device or system, including any network of conductors and apparatus connected thereto, shall not exceed the level of field strengths specified above.

#### Frequency Range of Radiated Measurement (For unintentional radiators)

Highest internal frequency ( $F_x$ ) (MHz)	Highest measurement frequency ( $F_M$ ) (GHz)
$F_x \leq 108 \text{ MHz}$	1
$108 \text{ MHz} < F_x \leq 500 \text{ MHz}$	2
$500 \text{ MHz} < F_x \leq 1 \text{ GHz}$	5
$F_x > 1 \text{ GHz}$	5 x $F_x$ up to a maximum of 6 GHz

$F_x$  is the highest fundamental frequency generated and/or used in the ITE or digital apparatus under test.

## 5.5 Harmonic Current Measurement

Limits for Class A equipment		Limits for Class D equipment		
Harmonic Order n	Max. permissible harmonics current A	Harmonic Order n	Max. permissible harmonics current per watt mA/W	Max. permissible harmonics current A
Odd harmonics		Odd Harmonics only		
3	2.30	3	3.4	2.30
5	1.14	5	1.9	1.14
7	0.77	7	1.0	0.77
9	0.40	9	0.5	0.40
11	0.33	11	0.35	0.33
13	0.21	13	0.30	0.21
$15 \leq n \leq 39$	$0.15 \times 15/n$	$15 \leq n \leq 39$	$3.85/n$	$0.15 \times 15/n$
Even harmonics				
2	1.08			
4	0.43			
6	0.30			
$8 \leq n \leq 40$	$0.23 \times 8/n$			

Note: 1. Class A and Class D are classified according to section 5 of EN 61000-3-2.

1. According to section 7 of EN 61000-3-2, the above limits for all equipment except for lighting equipment having an active input power > 75 W and no limits apply for equipment with an active input power up to and including 75 W.

### Classification of equipment

Class A	Class B	Class C	Class D
Balanced three-phase equipment; Household appliances excluding equipment as Class D; Tools excluding portable tools; Dimmers for incandescent lamps; Audio equipment; Equipment not specified in one of the three other classes.	Portable tools; Arc welding equipment which is not professional equipment.	Lighting equipment.	Equipment having a specified power less than or equal to 600 W of the following types: Personal computers and personal computer monitors; Television receivers; Refrigerators and freezers having one or more variable-speed drives to control compressor motor(s).

## 5.6 Voltage Fluctuations and Flicker Measurement

Test Item	Limit	Note
$P_{st}$	1.0	$P_{st}$ means short-term flicker indicator.
$P_{lt}$	0.65	$P_{lt}$ means long-term flicker indicator.
$T_{dt}$ (ms)	500	$T_{dt}$ means maximum time that $d(t)$ exceeds 3.3 %.
$d_c$ (%)	3.3%	$d_c$ means relative steady-state voltage change
$d_{max}$ (%)		$d_{max}$ means maximum relative voltage change. Control Method of Equipment (see below)
	4%	■ - without additional conditions
	6%	□ - switched manually, or - switched automatically more frequently than twice per day, and also has either a delayed restart (the delay not less than a few tens of seconds), or manual restart, after a power supply interruption
	7%	□ - attended whilst in use (for example: hair dryers, vacuum cleaners, kitchen equipment such as mixers, garden equipment such as lawn mowers, portable tools such as electric drills), or switched on automatically, or - is intended to be switched on manually, no more than twice per day, and also has either a delayed restart ( the delay being not less than a few tens of seconds) or manual restart, after a power supply interruption.

## 5.7 General immunity requirements

Port	Basic Standard	Test item	Test specification	Performance criteria
Power input (AC)	IEC 61000-4-4	Fast Transients, Common Mode (EFT)	±1 kV 5/50 ns (Tr/Th) 5 kHz, repetition frequency	B
	IEC 61000-4-5	Surge	Line to line: ±1 kV, 1.2/50 µs Line to earth: ±2 kV, 1.2/50 µs	B
	IEC 61000-4-6	Radio Frequency, Common Mode (CS)	0.15-10 MHz, 3V, 80% AM (1kHz), 10-30 MHz, 3V-1V, 80% AM (1kHz), 30-80 MHz, 1V, 80% AM (1kHz),	A
	IEC 61000-4-11	Voltage dips and interruptions (DIP)	<b>Voltage Dips:</b> < 5 % residual voltage, 0.5 cycle 70% residual voltage, 25 cycles (at 50Hz) <b>Voltage Interruption:</b> < 5 % residual voltage, 250 cycles (at 50 Hz)	B C C
DC power/ Wired network and Signal/ Control port	IEC 61000-4-4	Fast Transients Common Mode (EFT)	±0.5 kV 5/50 ns (Tr/Th) 100 kHz, repetition frequency for xDSL port 5 kHz, repetition frequency for other port	B
	IEC 61000-4-5	Surge	<b>Wired network ports</b> (directly connected to outdoor cables): Symmetrically operated: 10/700µs w/o primary protectors: ±1.0kV, or with primary protectors fitted: ±1.0kV and ±4.0kV, Coaxial or shielded operated: 1.2/50µs shield to ground: ±0.5 kV,	C B
			<b>DC power ports</b> (directly connected to outdoor cables): 1.2/50 µs each individual line to earth, or shield to ground: ±0.5 kV,	B
	IEC 61000-4-6	Radio Frequency Common Mode (CS)	0.15-10 MHz, 3V, 80% AM (1kHz), 10-30 MHz, 3V-1V, 80% AM (1kHz), 30-80 MHz, 1V, 80% AM (1kHz),	A
		Broadband impulse noise disturbances (Applicable only to xDSL ports.)	<b>Repetitive :</b> Impulse frequency profile : 0.15 – 0.5 MHz, 107 dBuV ; 0.5 – 10 MHz, 107 – 36 dBuV ; 10 – 30 MHz, 36 – 30 dBuV Burst duration : 0.70 ms Burst period :10 ms(for 50 Hz) At least 2 minutes for each port under test. <b>Isolated :</b> Impulse frequency profile : 0.15 –30 MHz, 110 dBuV Burst duration : 0.24 ms, 10 ms and 300 ms Isolated impulses : 5 times Interval : at least 60 seconds	A B

Port	Basic Standard	Test item	Test specification	Performance criteria
Enclosure	IEC 61000-4-2	Electrostatic Discharge (ESD)	±4 kV (contact) ±8 kV (Air)	B
	IEC 61000-4-3	Radio Frequency Electromagnetic Field (RS)	Swept Frequency Test: 80 to 1000(MHz), 3 V/m, 80 % AM (1 kHz) Spot Frequency Test: 1800, 2600, 3500, 5000 MHz (±1 %), 3V/m, 80% AM (1kHz)	A
	IEC 61000-4-8	Power Frequency Magnetic Field (PFMF)	1A/m, 50Hz	A

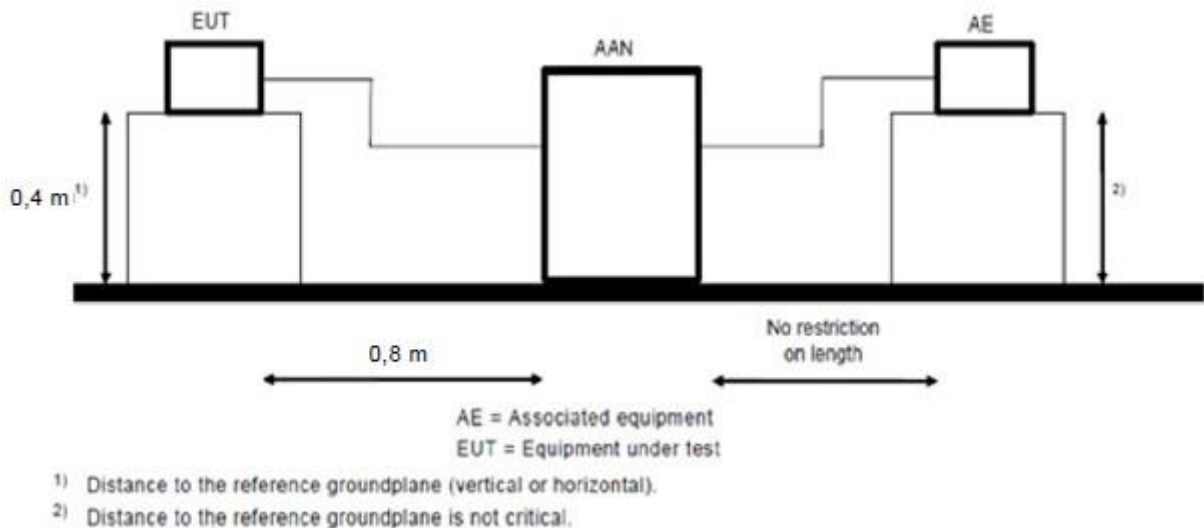


## 6.2 Conducted Emissions from Wired Network Ports

### Method of Using AANs:

- The EUT is placed 0.4 meters from the conducting wall of the shielded room and connected to AAN directly to reference ground plane.
- If voltage measurement is used, measure voltage at the measurement port of the AAN, correct the reading by adding the AAN voltage division factor, and compare to the voltage limit.
- It is not necessary to apply the current limit if a AAN is used.
- The test results of disturbance at telecommunication ports are recorded of six worst margins for quasi-peak (mandatory) [and average (if necessary)] values against the limits at frequencies of interest unless the margin is 20 dB or greater.

Note: The resolution bandwidth and video bandwidth of test receiver is 9kHz for quasi-peak detection (QP) and average detection (AV) at frequency 0.15MHz-30MHz.

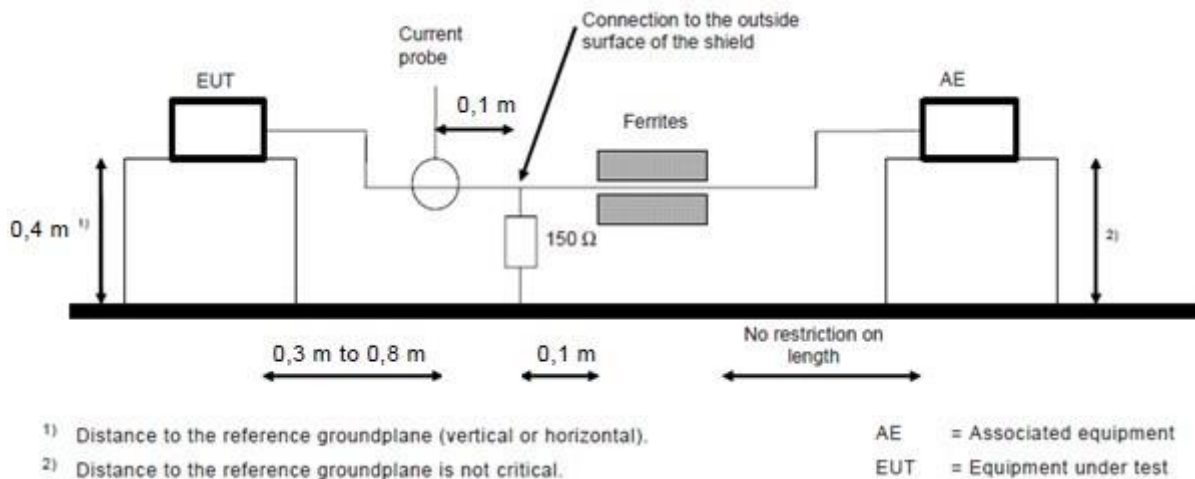


For the actual test configuration, please refer to the related Item – Photographs of the Test Configuration.

### Method of Using a 150 $\Omega$ load to the outside surface of the shielding cable:

- Breaks the external protective insulation (exposing the shield) and connect a 150 $\Omega$  resistor from the outside surface of the shield to ground.
- A current probe shall be placed at 0.1 m from the 150 $\Omega$  resistor. The current probe to EUT horizontal distance is between 0.3 m to 0.8 m.
- If current measurement is used, measure current at the measurement port of the current probe, correct the reading by adding the current probe division factor, and compare to the current limit.
- It is not necessary to apply the voltage limit if a current probe is used.
- The test results of disturbance at telecommunication ports are recorded of six worst margins for quasi-peak (mandatory) [and average (if necessary)] values against the limits at frequencies of interest unless the margin is 20 dB or greater.

Note: The resolution bandwidth and video bandwidth of test receiver is 9kHz for quasi-peak detection (QP) and average detection (AV) at frequency 0.15MHz-30MHz.



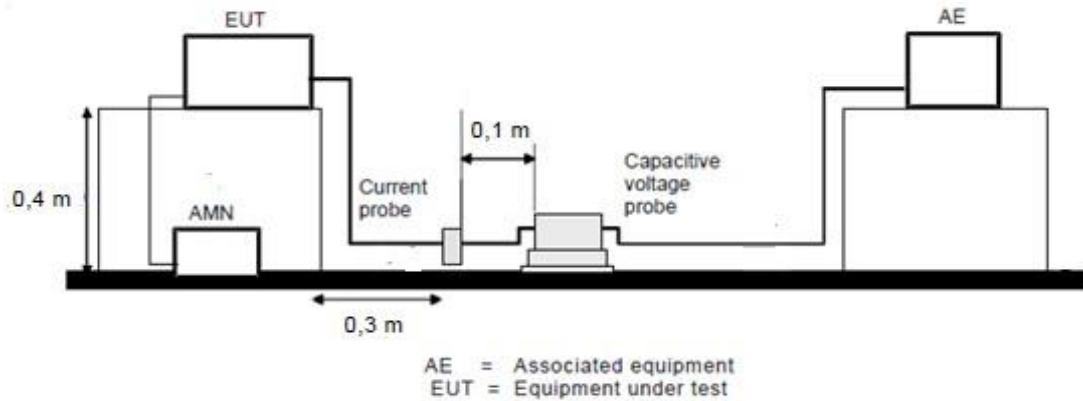
For the actual test configuration, please refer to the related Item – Photographs of the Test Configuration.



**Method of Using a combination of current probe and capacitive voltage probe:**

- a. Measure current with a current probe.
- b. Compare the measured current with the applicable current limit.
- c. Measure voltage with a capacitive voltage probe as specified in 5.2.2 of CISPR 16-1-2.
- d. Adjust the measured voltage as follows:
  - current margin  $\leq 6$  dB – subtract the actual current margin from measured voltage;
  - current margin  $> 6$  dB – subtract 6 dB from measured voltage.
- e. Compare adjusted voltage with the applicable voltage limit
- f. Both the measured current and the adjusted voltage shall be below the applicable
- g. The test results of disturbance at telecommunication ports are recorded of six worst margins for quasi-peak (mandatory) [and average (if necessary)] values against the limits at frequencies of interest unless the margin is 20 dB or greater.

Note: The resolution bandwidth and video bandwidth of test receiver is 9kHz for quasi-peak detection (QP) and average detection (AV) at frequency 0.15MHz-30MHz.

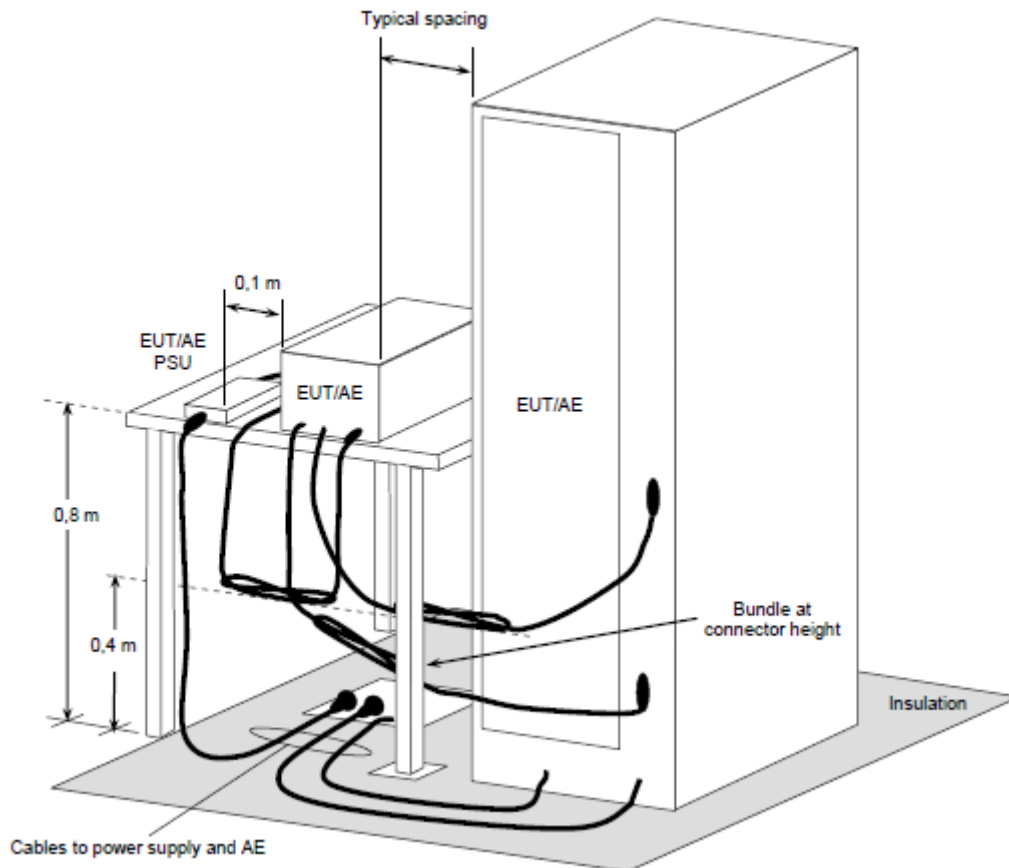


For the actual test configuration, please refer to the related Item – Photographs of the Test Configuration.

### 6.3 Radiated Emissions up to 1 GHz

- For the table-top EUT is placed on a 0.8 meter to the top of rotating table; for the the floor standing EUT shall be insulated (by insulation of maximum thickness of 150 mm) from the horizontal reference ground plane. The rotating table is rotated 360 degrees to determine the position of the highest radiation. If the equipment requires a dedicated ground connection, this shall be provided and bonded to the RGP.
- The EUT is set 10 meters away from the interference-receiving antenna, which is mounted on the top of a variable-height antenna tower.
- The antenna is a broadband antenna, and its height is varied from one meter to four meters above the ground to determine the maximum value of the field strength. Both horizontal and vertical polarizations of the antenna are set to make the measurement.
- For each suspected emission, the EUT is arranged to its worst case and then the antenna is tuned to heights from 1 m to 4 m and the rotatable table was turned from 0 degrees to 360 degrees to find the maximum reading.
- The test-receiver system is set to quasi-peak detect function and specified bandwidth with maximum hold mode when the test frequency is up to 1 GHz.

Note: The resolution bandwidth and video bandwidth of test receiver/spectrum analyzer is 120kHz for quasi-peak detection (QP) at frequency up to 1GHz.

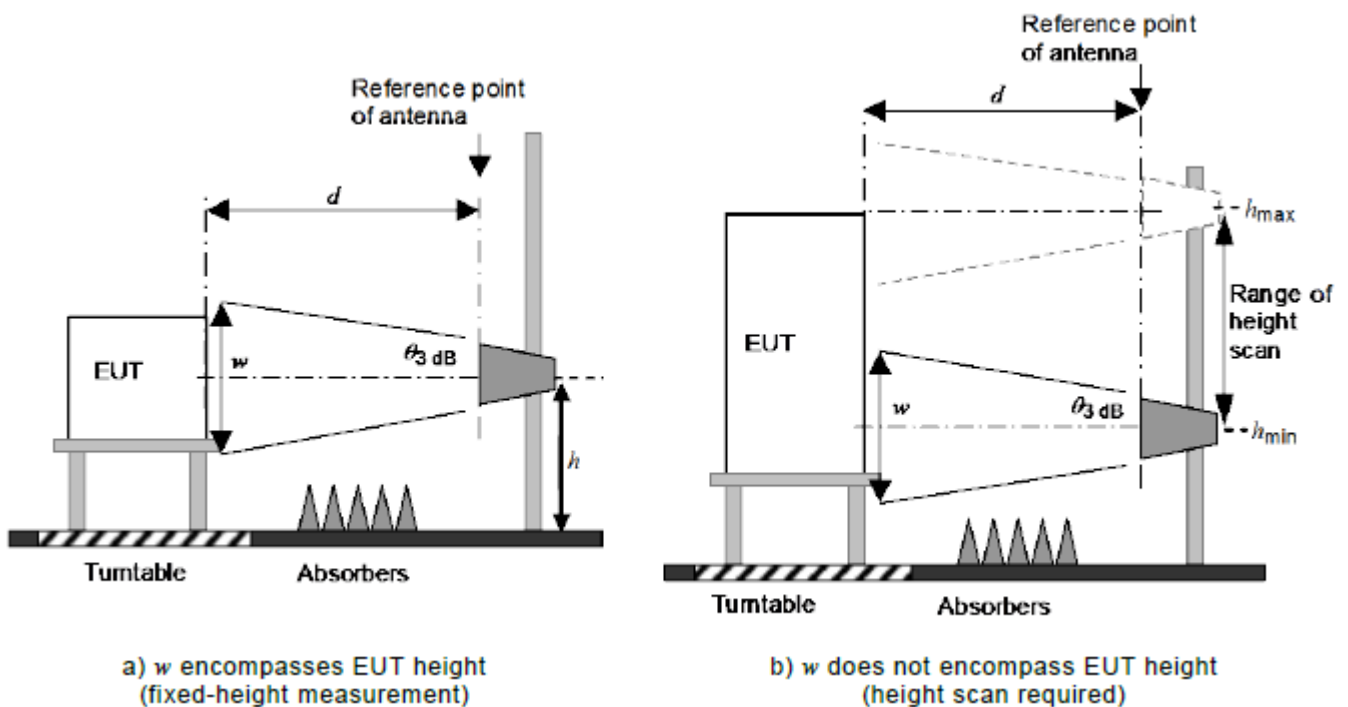


For the actual test configuration, please refer to the related Item – Photographs of the Test Configuration.

## 6.4 Radiated Emissions above 1 GHz

- For the table-top EUT is placed on a 0.8 meter to the top of rotating table; for the the floor standing EUT shall be insulated (by insulation of maximum thickness of 150 mm) from the horizontal reference ground plane. The rotating table is rotated 360 degrees to determine the position of the highest radiation. If the equipment requires a dedicated ground connection, this shall be provided and bonded to the RGP.
- The EUT was set  $d = 3$  meters away from the interference-receiving antenna, which was mounted on the top of a variable-height antenna tower.
- The height of antenna can be varied from one meter to four meters, the height of adjustment depends on the EUT height and the antenna 3dB beamwidth both, to detect the maximum value of the field strength. Both horizontal and vertical polarizations of the antenna are set to make the measurement.
- For each suspected emission, the EUT was arranged to its worst case and then the antenna was tuned to heights and the rotatable table was turned from 0 degrees to 360 degrees to find the maximum reading.
- The spectrum analyzer system was set to peak and average detects function and specified bandwidth with maximum hold mode when the test frequency is above 1 GHz.

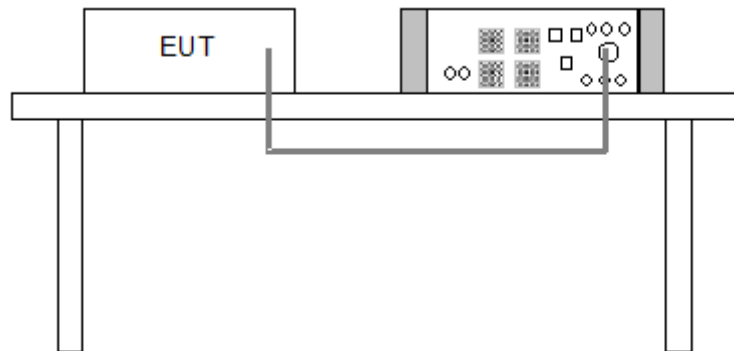
Note: The resolution bandwidth of test receiver/spectrum analyzer is 1MHz and video bandwidth is 3MHz for Peak detection (PK) at frequency above 1GHz. The resolution bandwidth of test receiver/spectrum analyzer is 1 MHz for Average detection (AV) at frequency above 1GHz.



For the actual test configuration, please refer to the related Item – Photographs of the Test Configuration.

## 6.5 Harmonics Current Measurement

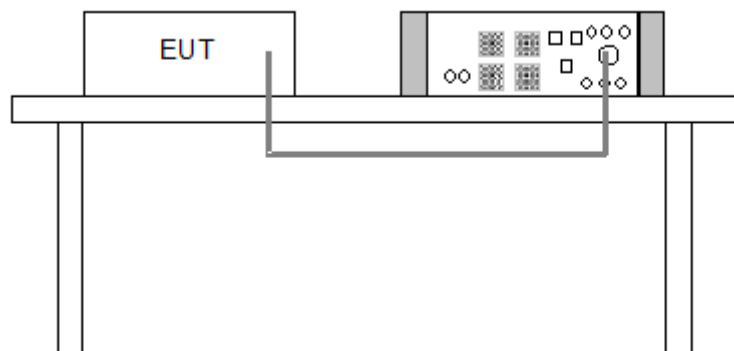
- The harmonic current limits apply to line currents and not to currents in the neutral conductor. Nevertheless, for single-phase equipment, it is permissible to measure the currents in the neutral conductor instead of the currents in the line.
- The EUT is tested as presented by, and in accordance with information provided by, the manufacturer. Preliminary operation of motor drives by the manufacturer may be needed before the tests are undertaken to ensure that results correspond with normal use.
- In all configurations, the use of additional load shall not cause the total output power available to be exceeded.
- The correspondent test program of test instrument to measure the current harmonics emanated from EUT is chosen. The measure time shall be not less than the time necessary for the EUT to be exercised.



For the actual test configuration, please refer to the related Item – Photographs of the Test Configuration.

## 6.6 Voltage Fluctuations and Flicker Measurement

- Controls or automatic programs of the EUT shall be set to produce the most unfavourable sequence of voltage changes, using only those combinations of controls and programmes which are mentioned by the manufacturer in the instruction manual, or are otherwise likely to be used.
- Preliminary operation of motor drives may be needed before the tests to ensure that results corresponding to those of normal use are obtained.
- During the flick measurement, the measure time shall include that part of whole operation cycle in which the EUT produce the most unfavorable sequence of voltage changes. The observation period for short-term flicker indicator is 10 minutes and the observation period for long-term flicker indicator is 2 hours.



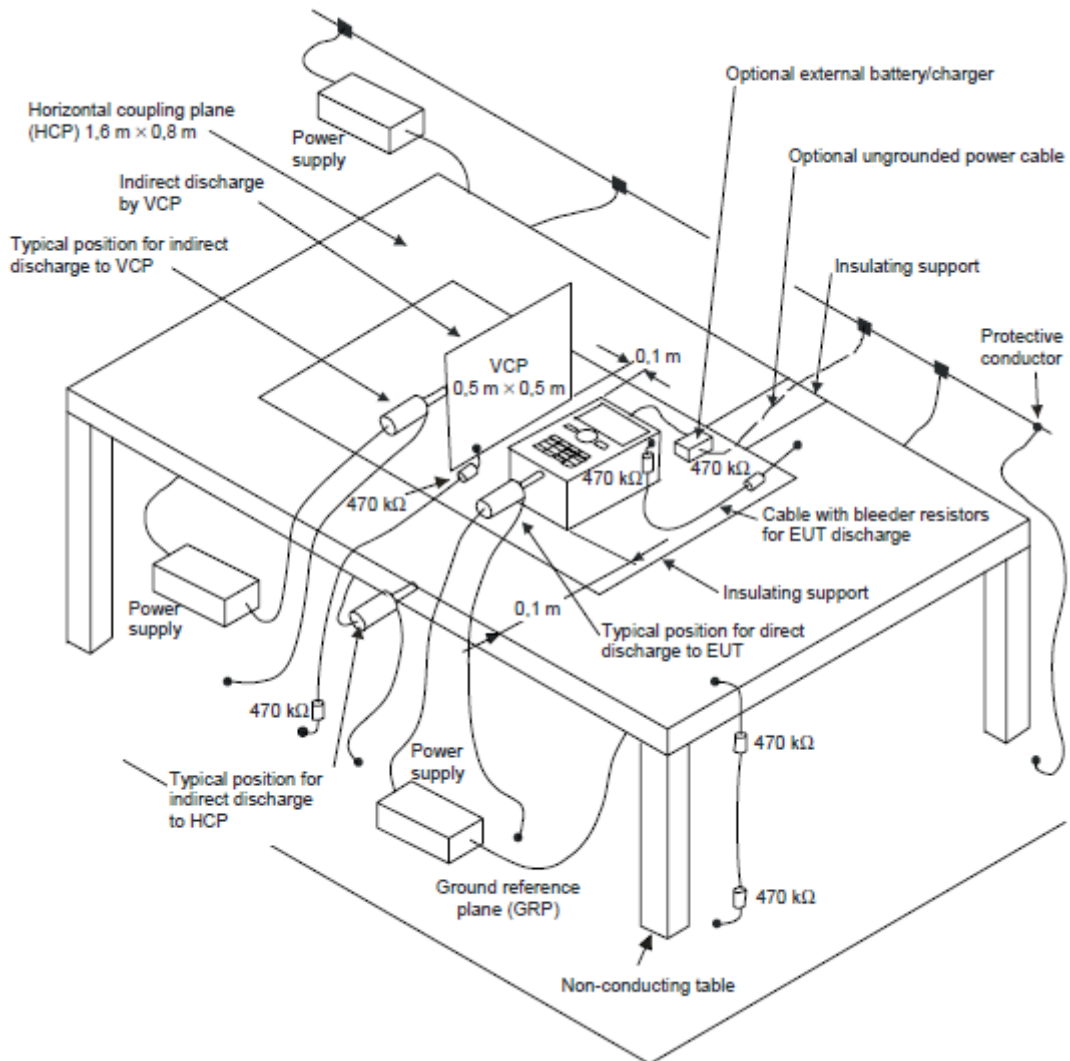
For the actual test configuration, please refer to the related Item – Photographs of the Test Configuration.

## 6.7 Electrostatic Discharge (ESD)

<b>Discharge Impedance:</b>	330 ohm / 150 pF
<b>Number of Discharge:</b>	Air – Direct: 10 discharges per location (each polarity) Contact – Direct & Indirect: 10 discharges per location (each polarity)
<b>Discharge Period:</b>	1-second minimum

The basic test procedure was in accordance with EN/IEC 61000-4-2:

- a. Electrostatic discharges were applied only to those points and surfaces of the EUT that are accessible to users during normal operation.
- b. The test was performed with at least ten single discharges on the pre-selected points in the most sensitive polarity.
- c. The time interval between two successive single discharges was at least 1 second.
- d. The ESD generator was held perpendicularly to the surface to which the discharge was applied and the return cable was at least 0.2 meters from the EUT.
- e. Contact discharges were applied to the non-insulating coating, with the pointed tip of the generator penetrating the coating and contacting the conducting substrate.
- f. Air discharges were applied with the round discharge tip of the discharge electrode approaching the EUT as fast as possible (without causing mechanical damage) to touch the EUT. After each discharge, the ESD generator was removed from the EUT and re-triggered for a new single discharge. The test was repeated until all discharges were complete.
- g. At least ten single discharges (in the most sensitive polarity) were applied to the **Horizontal Coupling Plane** at points on each side of the EUT. The ESD generator was positioned at a distance of 0.1 meters from the EUT with the discharge electrode touching the **HCP**.
- h. At least ten single discharges (in the most sensitive polarity) were applied to the center of one vertical edge of the **Vertical Coupling Plane** in sufficiently different positions that the four faces of the EUT were completely illuminated. The **VCP** (dimensions 0.5m x 0.5m) was placed vertically to and 0.1 meters from the EUT.



For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.

**NOTE:**

**TABLE-TOP EQUIPMENT**

The configuration consisted of a wooden table 0.8 meters high standing on the **Ground Reference Plane**. The **GRP** consisted of a sheet of aluminum at least 0.25mm thick, and 2.5 meters square connected to the protective grounding system. A **Horizontal Coupling Plane** (1.6m x 0.8m) was placed on the table and attached to the **GRP** by means of a cable with 940kΩ total impedance. The equipment under test, was installed in a representative system as described in section 7 of EN/IEC 61000-4-2, and its cables were placed on the **HCP** and isolated by an insulating support of 0.5mm thickness. A distance of 1-meter minimum was provided between the EUT and the walls of the laboratory and any other metallic structure.

**FLOOR-STANDING EQUIPMENT**

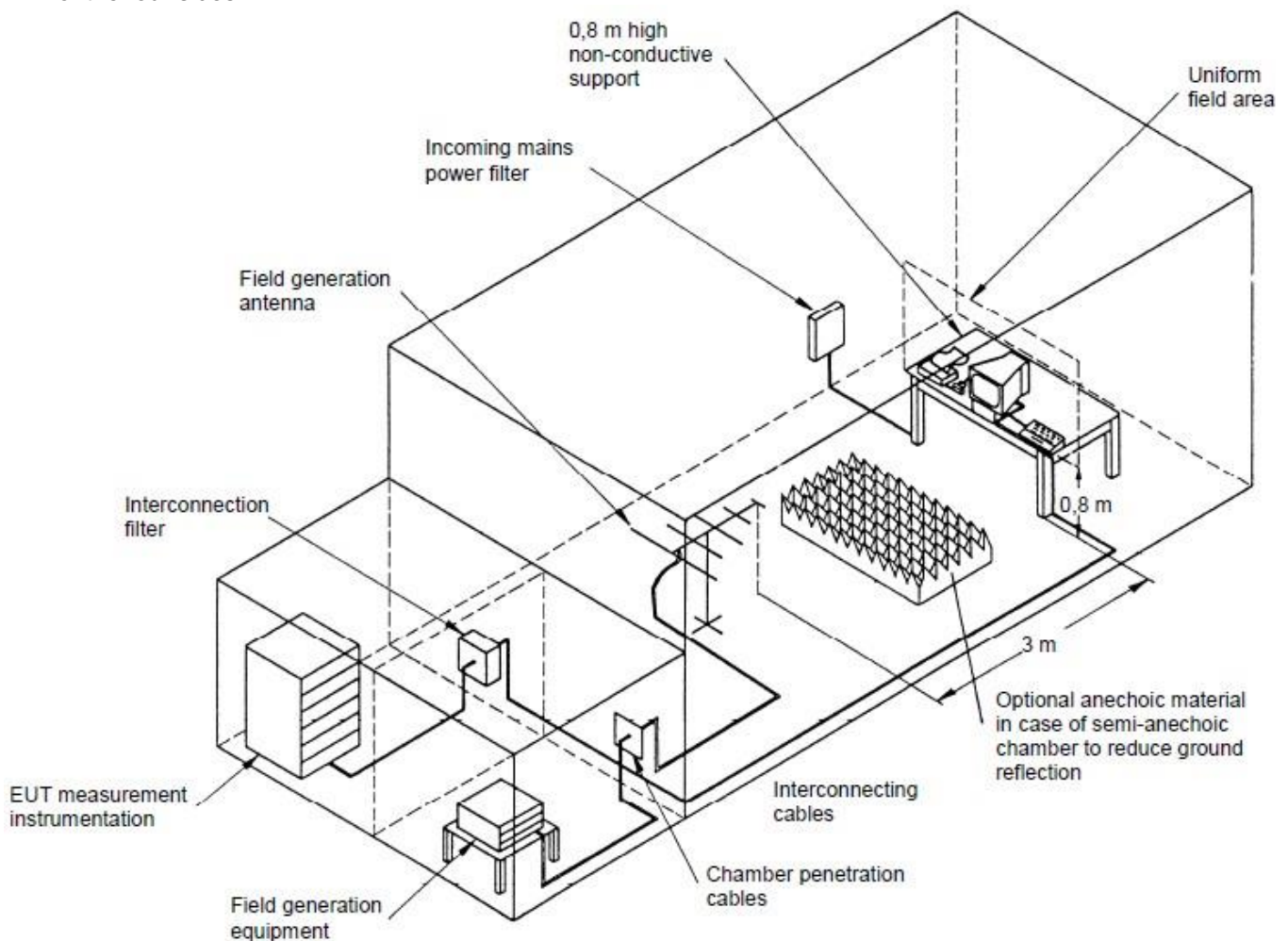
The equipment under test was installed in a representative system as described in section 7 of IEC 61000-4-2, and its cables were isolated from the Ground Reference Plane by an insulating support of 0.1-meter thickness. The GRP consisted of a sheet of aluminum that is at least 0.25mm thick, and 2.5 meters square connected to the protective grounding system and extended at least 0.5 me

## 6.8 Radio Frequency Electromagnetic Field (RS)

Modulation:	1kHz Sine Wave, 80%, AM Modulation
Frequency Step:	1 % of preceding frequency value
Dwell Time:	3 seconds

The test procedure was in accordance with EN/IEC 61000-4-3.

- The testing was performed in a modified semi-anechoic chamber.
- The frequency range shall be swept, with the signal 80% amplitude modulated with a 1kHz sine wave.
- The test was performed with the EUT exposed to both vertically and horizontally polarized fields on each of the four sides.



For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.

### **NOTE:**

#### **TABLETOP EQUIPMENT**

The EUT installed in a representative system as described in section 7 of EN/IEC 61000-4-3 was placed on a non-conductive table 0.8 meters in height. The system under test was connected to the power and signal wire according to relevant installation instructions.

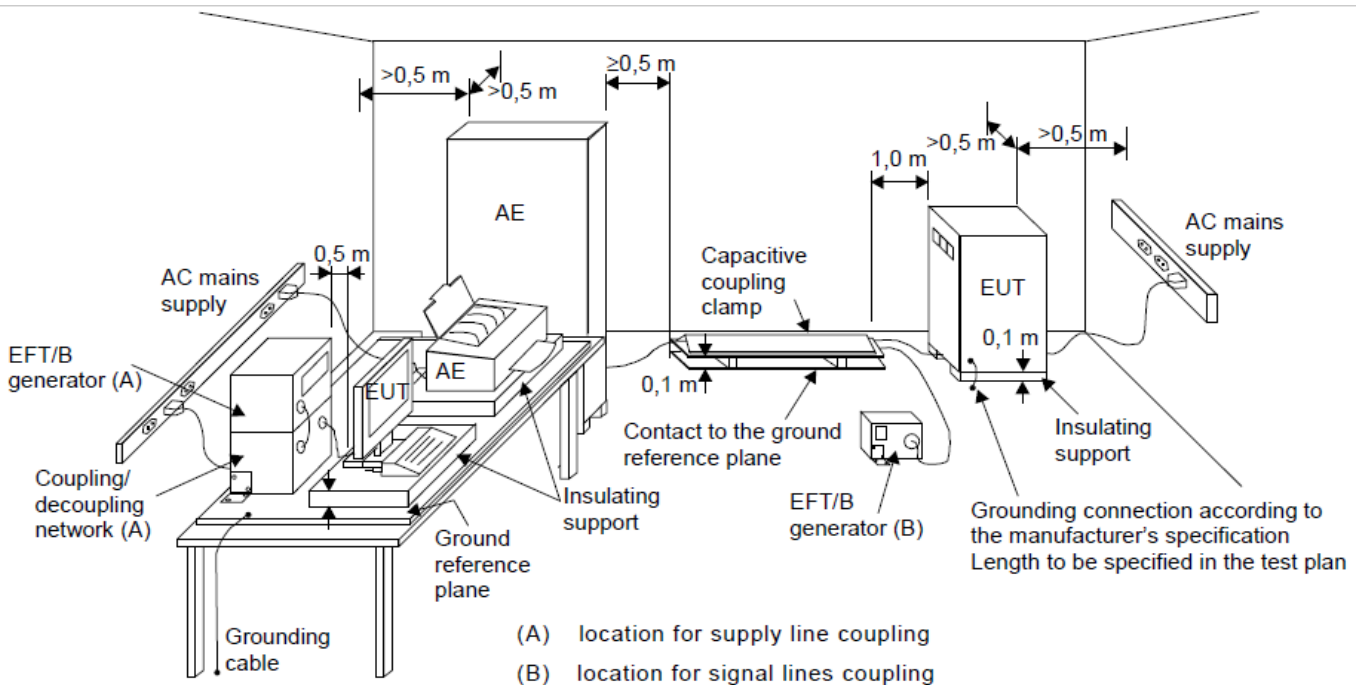
#### **FLOOR STANDING EQUIPMENT**

The EUT installed in a representative system as described in section 7 of EN/IEC 61000-4-3 was placed on a non-conductive wood support 0.1 meters in height. The system under test was connected to the power and signal wire according to relevant installation instructions.

## 6.9 Fast Transients Common Mode (EFT)

Impulse Repetition Frequency:	xDSL telecommunication port: 100kHz others: 5kHz
Impulse Wave Shape:	5/50 ns
Burst Duration:	0.75 ms for 100kHz Repetition Frequency 15 ms for 5kHz Repetition Frequency
Burst Period:	300 ms
Test Duration:	1 min.

- Both positive and negative polarity discharges were applied.
- The distance between any coupling devices and the EUT should be 0.5 m for table-top equipment testing, and 1.0 m for floor standing equipment.
- The duration time of each test sequential was 1 minute.
- The transient/burst waveform was in accordance with EN/IEC 61000-4-4, 5/50 ns.



For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.



## 6.10 Surge

Pulse Repetition Rate:	20 sec.
Number of Tests:	5 positive and 5 negative at selected points

### a. EUT Power ports:

The surge shall be applied to the EUT power supply terminals via the capacitive coupling network. Decoupling networks are required in order to avoid possible adverse effects on equipment not under test that may be powered by the same lines and to provide sufficient decoupling impedance to the surge wave. The power cord between the EUT and the coupling network shall not exceed 2 meters in length.

For double-insulated products without PE or external earth connections, the test shall be done in a similar way as for grounded products but without adding any additional external grounded connections. If there are no other possible connections to earth, line-to-ground tests may be omitted.

### b. Wired network ports

- Unshielded unsymmetrical interconnection lines:

The coupling / decoupling networks shall not influence the specified functional conditions of the EUT. The interconnection line between the EUT and the coupling network shall not exceed 2 meters in length.

No line-to-ground surges are applied for double-insulated products (i.e. products without any dedicated earth terminal).

- Unshielded symmetrical interconnection lines:

For symmetrical interconnection lines and high-speed interconnection lines, the CDN shall be selected to match the number of lines/pairs existing the cable. If coupling arrestors are use, test levels below the ignition point of the coupling arrestor cannot be specified.

The interconnection line between the EUT and the coupling/decoupling networks shall not exceed 2 meters in length.

In order to avoid the coupling and decoupling capacitors having a filtering effect on the data transfer, a balanced high frequency design associating the coupling capacitors with coupling chokes is required. Where normal functioning of high speed communications lines cannot be achieved because of the impact of the CDN on the EUT, product committees should specify appropriate operation or that no surge immunity test is required.

- Shielded lines:

The EUT is isolated from ground and the surge is applied to its metallic enclosure; the termination (or auxiliary equipment) at the port(s) under test is grounded. This test applies to equipment with one or more shielded cables.

The length of the cable between the port(s) under test and the device attached to the other end of the cable (AE in Figure 12) shall be:

- 20 m (preferred length) or,
- the shortest length over 10 m, where the manufacturer provides pre-assembled cables used in actual installations.

No test shall be required for cables which according to the manufacturer's specification are  $\leq 10$  m.

Rules for application of the surge to shielded lines:

- a) Shields grounded at both ends:
  - the test shall be carried out.

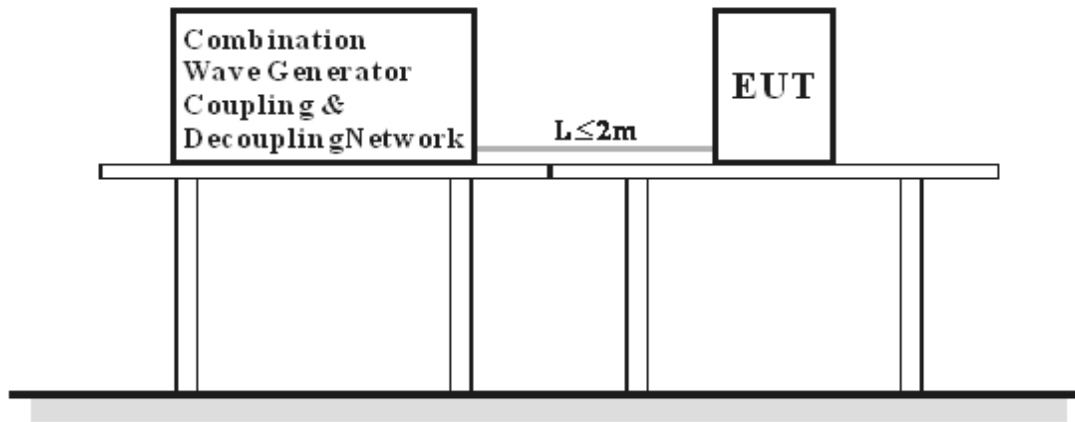
The test level is applied on shields with a  $2 \Omega$  generator source impedance and with the  $18 \mu\text{F}$  capacitor.

- b) Shields grounded at one end:

- the test shall be carried out according to unshielded unsymmetrical interconnection lines or unshielded symmetrical interconnection lines because the shield does not provide any protection against surges

induced by magnetic fields.

For EUTs which do not have metallic enclosures, the surge is applied directly to the shielded cable at the EUT side.

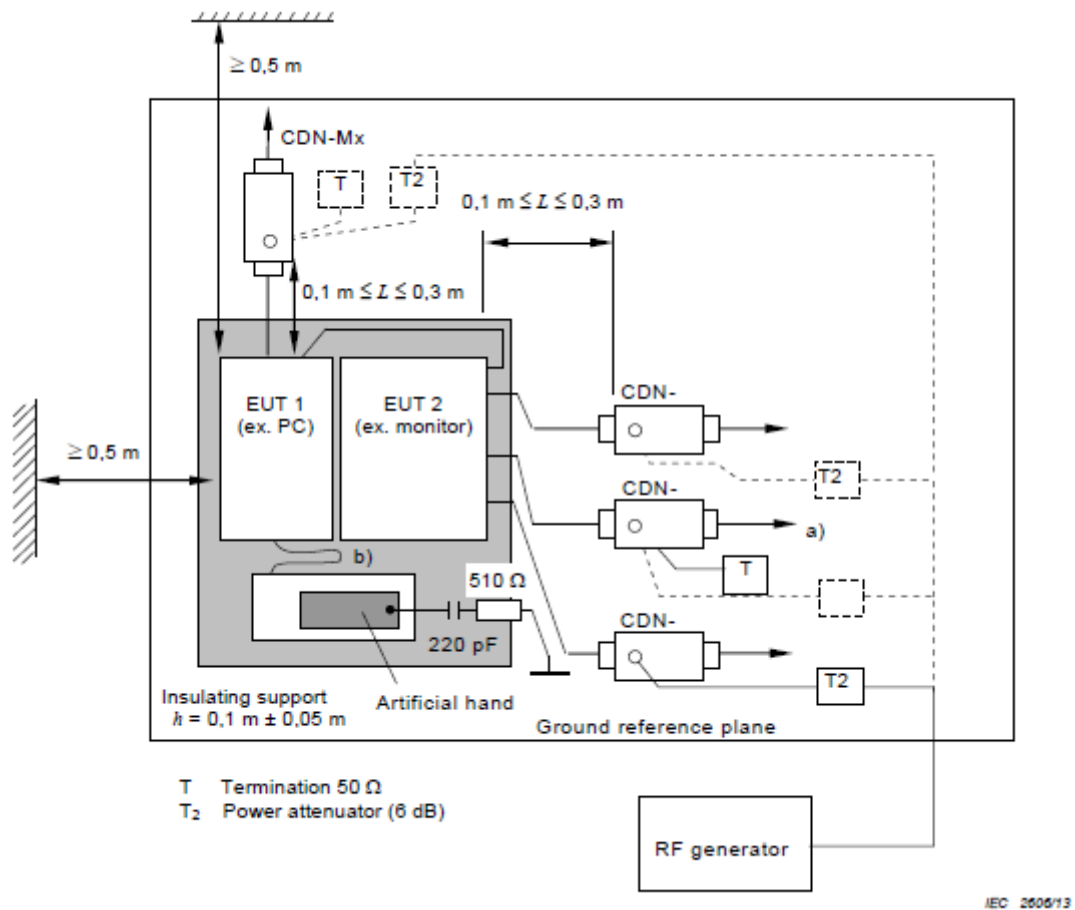


For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.

## 6.11 Radio Frequency Common Mode (CS)

<b>Modulation:</b>	1kHz Sine Wave, 80%, AM Modulation
<b>Frequency Step:</b>	1 % of preceding frequency value
<b>Dwell Time</b>	3 seconds

- The EUT shall be tested within its intended operating and climatic conditions.
- An artificial hand was placed on the hand-held accessory and connected to the ground reference plane.
- One of the CDNs not used for injection was terminated with 50 ohm, providing only one return path. All other CDNs were coupled as decoupling networks.
- The frequency range shall be swept, using the signal level established during the setting process and with a disturbance signal of 80 % amplitude. The signal is modulated with a 1 kHz sine wave, pausing to adjust the RF signal level or the switch coupling devices as necessary. Where the frequency is swept incrementally, the step size shall not exceed 1 % of the preceding frequency value.
- Attempts should be made to fully exercise the EUT during testing, and to fully interrogate all exercise modes selected for susceptibility.

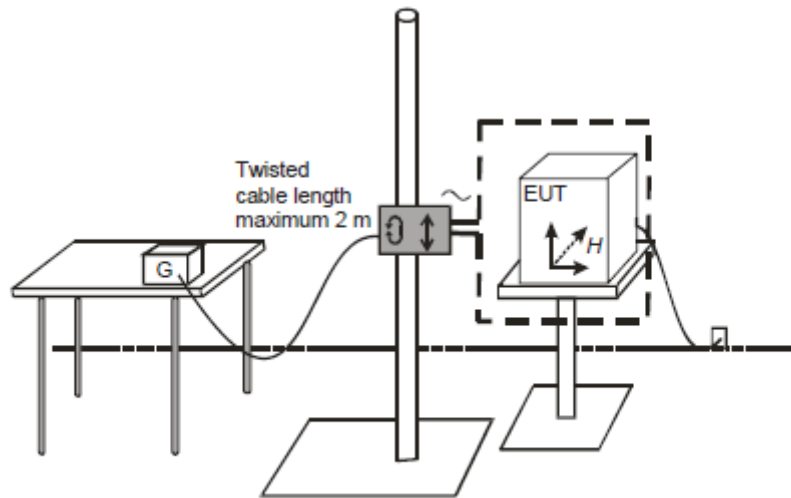
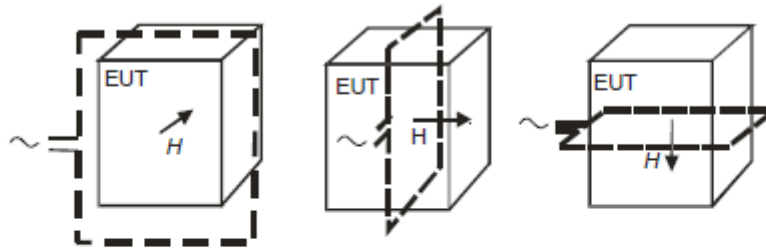


**Note:** 1. The EUT clearance from any metallic obstacles shall be at least 0,5 m.  
 2. Interconnecting cables ( $\leq 1$  m) belonging to the EUT shall remain on the insulating support.  
 For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.

## 6.12 Power Frequency Magnetic Field (PFMF)

<b>Observation Time:</b>	1 minute
<b>Inductance Coil:</b>	Rectangular coil, 1 m x 1 m (L x W)

- The equipment is configured and connected to satisfy its functional requirements.
- The power supply, input and output circuits shall be connected to the sources of power supply, control and signal.
- The cables supplied or recommended by the equipment manufacturer shall be used. 1 meter of all cables used shall be exposed to the magnetic field.

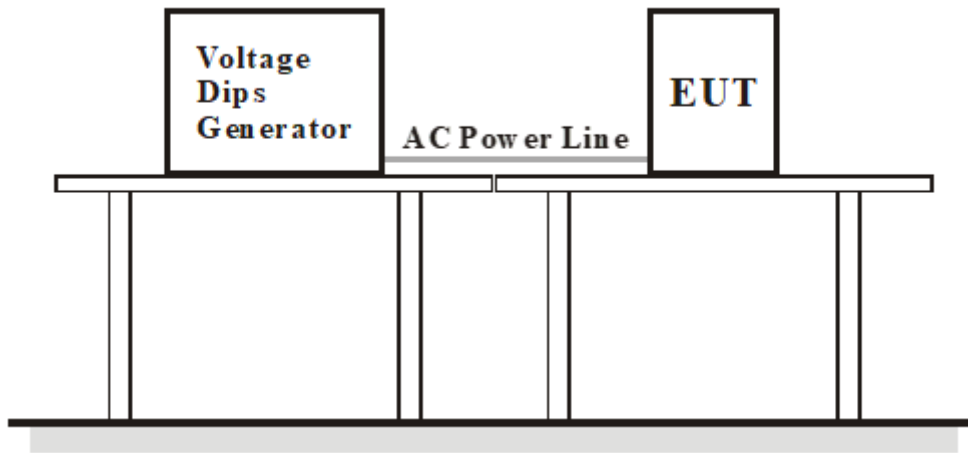


For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.

### 6.13 Voltage Dips and Interruptions (DIP)

Interval between Event:	10 seconds
Sync Angle (degrees):	0° / 180°
Test Cycle:	3 times

- a. The test shall be performed with the EUT connected to the test generator with the shortest power supply cable as specified by the EUT manufacturer. If no cable length is specified, it shall be the shortest possible length suitable to the application of the EUT.
- b. The EUT shall be tested for each selected combination of test levels and duration with a sequence of 3 dips/interruptions with intervals of 10 s minimum (between each test event). Each representative mode of operation shall be tested. Abrupt changes in supply voltage shall occur at 0 voltage crossover point of the voltage waveform.



For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.

## 7 Test Results

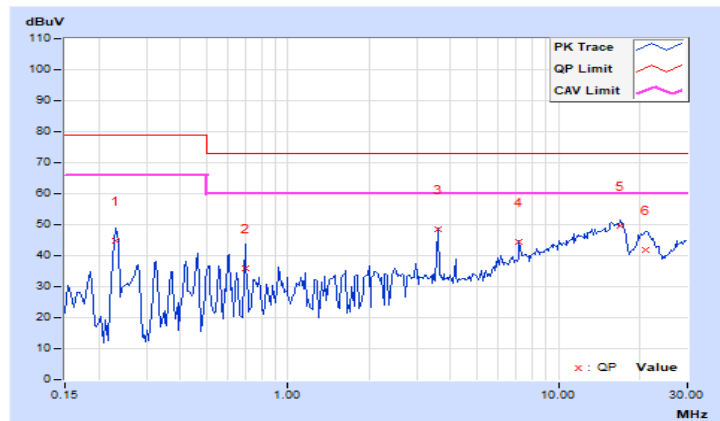
### 7.1 Conducted emissions from Power Ports

Frequency Range	150kHz ~ 30MHz	Detector Function & Resolution Bandwidth	Quasi-Peak (QP) / Average (AV), 9kHz
Input Power	110Vac, 60Hz	Environmental Conditions	25°C, 70%RH, 1000mbar
Tested by	Adam Chen	Test Date	2021/5/24
Test Mode	Mode 2		

Phase Of Power : Line (L)										
No	Frequency (MHz)	Correction Factor (dB)	Reading Value (dBuV)		Emission Level (dBuV)		Limit (dBuV)		Margin (dB)	
			Q.P.	AV.	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.
1	0.23203	9.70	35.08	32.06	44.78	41.76	79.00	66.00	-34.22	-24.24
2	0.69688	9.71	26.31	21.06	36.02	30.77	73.00	60.00	-36.98	-29.23
<b>3</b>	<b>3.58984</b>	<b>9.83</b>	<b>38.75</b>	<b>38.74</b>	<b>48.58</b>	<b>48.57</b>	<b>73.00</b>	<b>60.00</b>	<b>-24.42</b>	<b>-11.43</b>
4	7.17969	9.87	34.73	33.76	44.60	43.63	73.00	60.00	-28.40	-16.37
5	16.84766	9.95	39.57	29.43	49.52	39.38	73.00	60.00	-23.48	-20.62
6	20.98438	9.97	31.71	20.31	41.68	30.28	73.00	60.00	-31.32	-29.72

#### Remarks:

1. Q.P. and AV. are abbreviations of quasi-peak and average individually.
2. The emission levels of other frequencies were very low against the limit.
3. Margin value = Emission level – Limit value
4. Correction factor = Insertion loss + Cable loss
5. Emission Level = Correction Factor + Reading Value

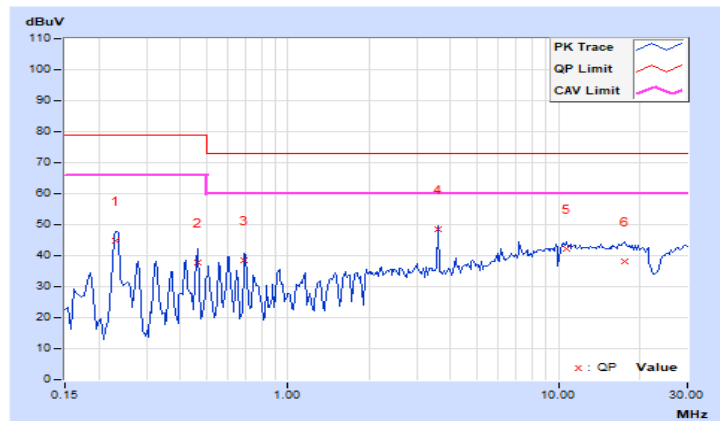


<b>Frequency Range</b>	150kHz ~ 30MHz	<b>Detector Function &amp; Resolution Bandwidth</b>	Quasi-Peak (QP) / Average (AV), 9kHz
<b>Input Power</b>	110Vac, 60Hz	<b>Environmental Conditions</b>	25°C, 70%RH, 1000mbar
<b>Tested by</b>	Adam Chen	<b>Test Date</b>	2021/5/24
<b>Test Mode</b>	Mode 2		

Phase Of Power : Neutral (N)										
No	Frequency (MHz)	Correction Factor (dB)	Reading Value (dBuV)		Emission Level (dBuV)		Limit (dBuV)		Margin (dB)	
			Q.P.	AV.	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.
1	0.23203	9.70	34.96	31.96	44.66	41.66	79.00	66.00	-34.34	-24.34
2	0.46250	9.71	27.96	22.59	37.67	32.30	79.00	66.00	-41.33	-33.70
3	0.69297	9.72	28.65	21.86	38.37	31.58	73.00	60.00	-34.63	-28.42
<b>4</b>	<b>3.58984</b>	<b>9.83</b>	<b>38.75</b>	<b>38.74</b>	<b>48.58</b>	<b>48.57</b>	<b>73.00</b>	<b>60.00</b>	<b>-24.42</b>	<b>-11.43</b>
5	10.76953	9.92	32.13	28.97	42.05	38.89	73.00	60.00	-30.95	-21.11
6	17.50866	10.01	28.04	21.72	38.05	31.73	73.00	60.00	-34.95	-28.27

**Remarks:**

1. Q.P. and AV. are abbreviations of quasi-peak and average individually.
2. The emission levels of other frequencies were very low against the limit.
3. Margin value = Emission level – Limit value
4. Correction factor = Insertion loss + Cable loss
5. Emission Level = Correction Factor + Reading Value

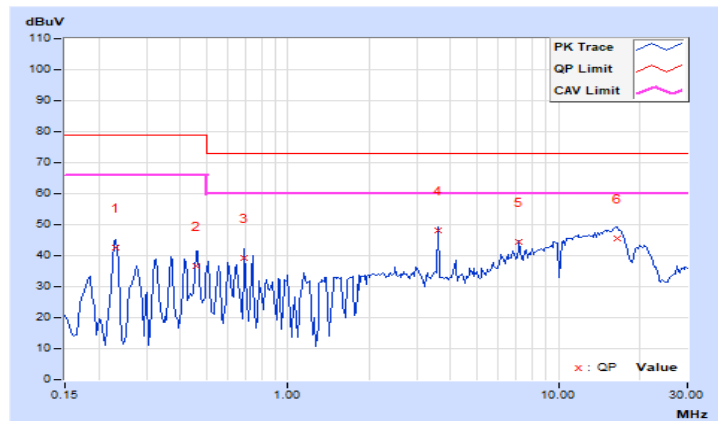


<b>Frequency Range</b>	150kHz ~ 30MHz	<b>Detector Function &amp; Resolution Bandwidth</b>	Quasi-Peak (QP) / Average (AV), 9kHz
<b>Input Power</b>	230Vac, 50Hz	<b>Environmental Conditions</b>	25°C, 70%RH, 1000mbar
<b>Tested by</b>	Adam Chen	<b>Test Date</b>	2021/5/24
<b>Test Mode</b>	Mode 2		

Phase Of Power : Line (L)										
No	Frequency (MHz)	Correction Factor (dB)	Reading Value (dBuV)		Emission Level (dBuV)		Limit (dBuV)		Margin (dB)	
			Q.P.	AV.	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.
1	0.23203	9.70	32.79	29.83	42.49	39.53	79.00	66.00	-36.51	-26.47
2	0.45859	9.71	27.10	21.48	36.81	31.19	79.00	66.00	-42.19	-34.81
3	0.68906	9.71	29.48	26.02	39.19	35.73	73.00	60.00	-33.81	-24.27
4	3.58984	9.83	38.49	38.48	48.32	48.31	73.00	60.00	-24.68	-11.69
5	7.17969	9.87	34.67	33.80	44.54	43.67	73.00	60.00	-28.46	-16.33
6	16.48828	9.95	35.78	28.68	45.73	38.63	73.00	60.00	-27.27	-21.37

**Remarks:**

1. Q.P. and AV. are abbreviations of quasi-peak and average individually.
2. The emission levels of other frequencies were very low against the limit.
3. Margin value = Emission level – Limit value
4. Correction factor = Insertion loss + Cable loss
5. Emission Level = Correction Factor + Reading Value



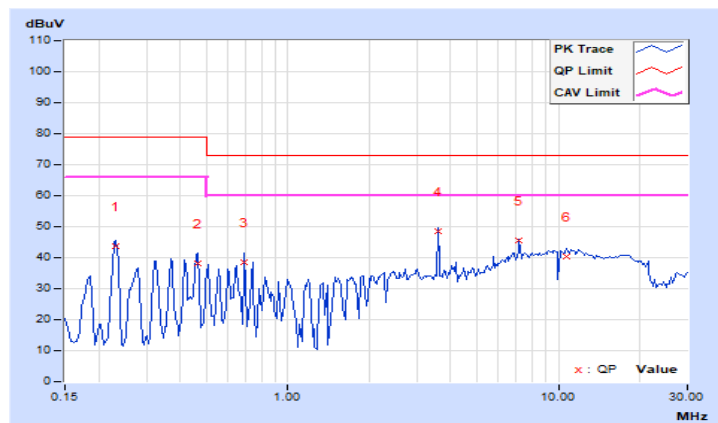


<b>Frequency Range</b>	150kHz ~ 30MHz	<b>Detector Function &amp; Resolution Bandwidth</b>	Quasi-Peak (QP) / Average (AV), 9kHz
<b>Input Power</b>	230Vac, 50Hz	<b>Environmental Conditions</b>	25°C, 70%RH, 1000mbar
<b>Tested by</b>	Adam Chen	<b>Test Date</b>	2021/5/24
<b>Test Mode</b>	Mode 2		

Phase Of Power : Neutral (N)										
No	Frequency (MHz)	Correction Factor (dB)	Reading Value (dBuV)		Emission Level (dBuV)		Limit (dBuV)		Margin (dB)	
			Q.P.	AV.	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.
1	0.23203	9.70	33.91	29.95	43.61	39.65	79.00	66.00	-35.39	-26.35
2	0.46250	9.71	28.30	22.29	38.01	32.00	79.00	66.00	-40.99	-34.00
3	0.68906	9.72	28.87	25.82	38.59	35.54	73.00	60.00	-34.41	-24.46
4	3.58984	9.83	38.65	38.64	48.48	48.47	73.00	60.00	-24.52	-11.53
5	7.17969	9.88	35.74	33.78	45.62	43.66	73.00	60.00	-27.38	-16.34
6	10.76172	9.92	30.44	24.99	40.36	34.91	73.00	60.00	-32.64	-25.09

**Remarks:**

1. Q.P. and AV. are abbreviations of quasi-peak and average individually.
2. The emission levels of other frequencies were very low against the limit.
3. Margin value = Emission level – Limit value
4. Correction factor = Insertion loss + Cable loss
5. Emission Level = Correction Factor + Reading Value



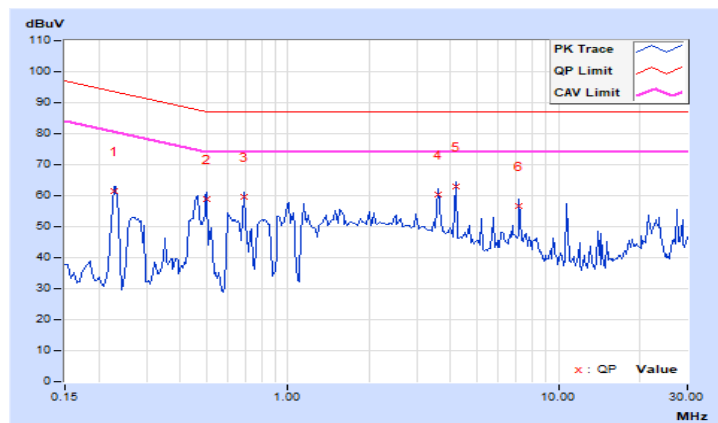
## 7.2 Conducted Emissions from Wired Network Ports

<b>Frequency Range</b>	150kHz ~ 30MHz	<b>Detector Function &amp; Resolution Bandwidth</b>	Quasi-Peak (QP) / Average (AV), 9kHz
<b>Input Power</b>	230Vac, 50Hz	<b>Environmental Conditions</b>	25°C, 75%RH, 1000mbar
<b>Tested by</b>	Adam Chen	<b>Test Date</b>	2021/5/24
<b>Test Mode</b>	Mode 2A RJ45 TELECOM PORT (1Gbps, TFGEN+PING)		

No	Frequency (MHz)	Correction Factor (dB)	Reading Value (dBuV)		Emission Level (dBuV)		Limit (dBuV)		Margin (dB)	
			Q.P.	AV.	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.
1	0.22812	9.92	51.48	50.63	61.40	60.55	93.52	80.52	-32.12	-19.97
2	0.50156	9.91	49.02	48.26	58.93	58.17	87.00	74.00	-28.07	-15.83
3	0.68906	9.90	49.58	48.67	59.48	58.57	87.00	74.00	-27.52	-15.43
4	3.58984	10.03	50.52	50.51	60.55	60.54	87.00	74.00	-26.45	-13.46
5	4.16797	10.06	52.96	52.95	63.02	63.01	87.00	74.00	-23.98	-10.99
6	7.17969	10.15	46.69	46.62	56.84	56.77	87.00	74.00	-30.16	-17.23

### Remarks:

1. Q.P. and AV. are abbreviations of quasi-peak and average individually.
2. The emission levels of other frequencies were very low against the limit.
3. Margin value = Emission level – Limit value
4. Correction factor = Insertion loss + Cable loss
5. Emission Level = Correction Factor + Reading Value

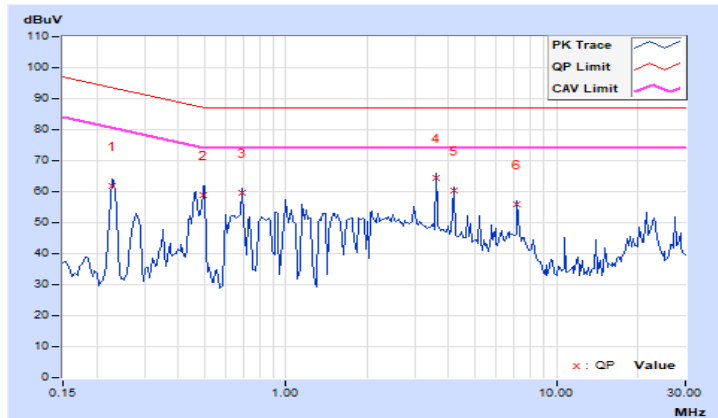


<b>Frequency Range</b>	150kHz ~ 30MHz	<b>Detector Function &amp; Resolution Bandwidth</b>	Quasi-Peak (QP) / Average (AV), 9kHz
<b>Input Power</b>	230Vac, 50Hz	<b>Environmental Conditions</b>	25°C, 75%RH, 1000mbar
<b>Tested by</b>	Adam Chen	<b>Test Date</b>	2021/5/24
<b>Test Mode</b>	Mode 2B RJ45 TELECOM PORT (1Gbps, TFGEN+PING)		

No	Frequency (MHz)	Correction Factor (dB)	Reading Value (dBuV)		Emission Level (dBuV)		Limit (dBuV)		Margin (dB)	
			Q.P.	AV.	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.
1	0.22812	9.92	51.95	50.93	61.87	60.85	93.52	80.52	-31.65	-19.67
2	0.49766	9.91	48.97	45.05	58.88	54.96	87.04	74.04	-28.16	-19.08
3	0.68906	9.90	49.73	49.72	59.63	59.62	87.00	74.00	-27.37	-14.38
<b>4</b>	<b>3.58984</b>	<b>10.03</b>	<b>54.27</b>	<b>54.26</b>	<b>64.30</b>	<b>64.29</b>	<b>87.00</b>	<b>74.00</b>	<b>-22.70</b>	<b>-9.71</b>
5	4.16797	10.06	50.27	50.26	60.33	60.32	87.00	74.00	-26.67	-13.68
6	7.17969	10.15	45.64	45.63	55.79	55.78	87.00	74.00	-31.21	-18.22

**Remarks:**

1. Q.P. and AV. are abbreviations of quasi-peak and average individually.
2. The emission levels of other frequencies were very low against the limit.
3. Margin value = Emission level – Limit value
4. Correction factor = Insertion loss + Cable loss
5. Emission Level = Correction Factor + Reading Value



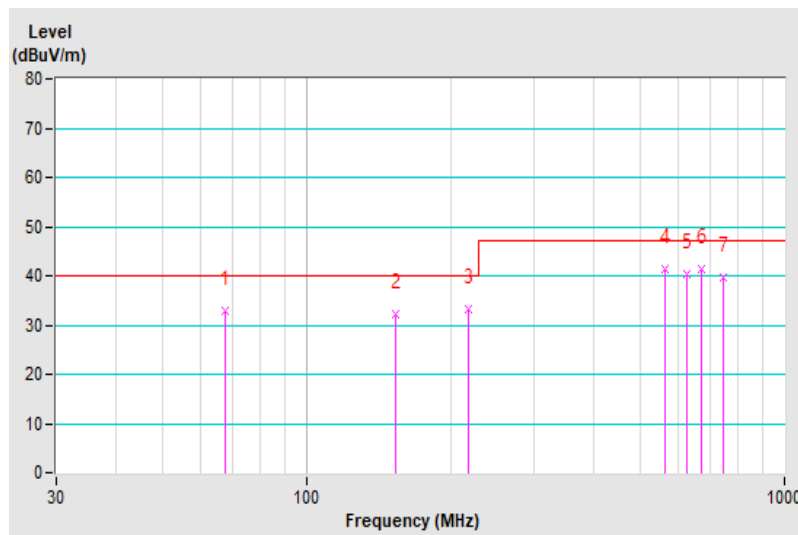
### 7.3 Radiated Emissions up to 1 GHz

<b>Frequency Range</b>	30MHz ~ 1GHz	<b>Detector Function &amp; Resolution Bandwidth</b>	Quasi-Peak (QP), 120kHz
<b>Tested By</b>	ED. Lin	<b>Environmental Conditions</b>	29.0°C, 62.0%RH, 999mbar
<b>Test Mode</b>	Mode 2	<b>Test Date</b>	2021/5/27

Antenna Polarity & Test Distance : Horizontal at 10 m								
No	Frequency (MHz)	Emission Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Antenna Height (m)	Table Angle (Degree)	Raw Value (dBuV)	Correction Factor (dB/m)
1	67.63	32.87 QP	40.00	-7.13	4.00 H	147	44.61	-11.74
2	154.21	32.29 QP	40.00	-7.71	4.00 H	217	41.45	-9.16
3	218.41	33.12 QP	40.00	-6.88	3.99 H	213	44.96	-11.84
4	562.32	41.47 QP	47.00	-5.53	2.19 H	297	43.70	-2.23
5	624.23	40.21 QP	47.00	-6.79	1.67 H	266	40.79	-0.58
6	672.21	41.36 QP	47.00	-5.64	1.72 H	218	41.45	-0.09
7	742.69	39.63 QP	47.00	-7.37	1.03 H	220	37.73	1.90

**Remarks:**

1. Emission Level(dBuV/m) = Raw Value(dBuV) + Correction Factor(dB/m)
2. Correction Factor(dB/m) = Antenna Factor (dB/m) + Cable Factor (dB) – Pre-Amplifier Factor (dB)
3. The other emission levels were very low against the limit.
4. Margin value = Emission level – Limit value

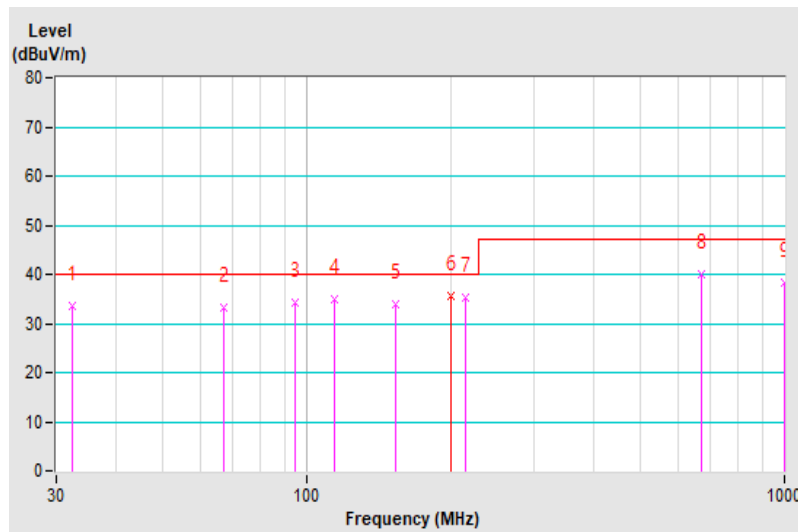


Frequency Range	30MHz ~ 1GHz	Detector Function & Resolution Bandwidth	Quasi-Peak (QP), 120kHz
Tested By	ED. Lin	Environmental Conditions	29.0°C, 62.0%RH, 999mbar
Test Mode	Mode 2	Test Date	2021/5/27

Antenna Polarity & Test Distance : Vertical at 10 m								
No	Frequency (MHz)	Emission Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Antenna Height (m)	Table Angle (Degree)	Raw Value (dBuV)	Correction Factor (dB/m)
1	32.32	33.60 QP	40.00	-6.40	1.00 V	90	43.13	-9.53
2	67.32	33.10 QP	40.00	-6.90	1.00 V	210	52.86	-19.76
3	94.96	34.23 QP	40.00	-5.77	1.00 V	40	50.44	-16.21
4	114.23	34.88 QP	40.00	-5.12	1.00 V	217	48.83	-13.95
5	153.65	33.96 QP	40.00	-6.04	1.00 V	144	47.96	-14.00
<b>6</b>	<b>199.99</b>	<b>35.52 QP</b>	<b>40.00</b>	<b>-4.48</b>	<b>1.00 V</b>	<b>244</b>	<b>51.32</b>	<b>-15.80</b>
7	215.00	35.32 QP	40.00	-4.68	1.00 V	253	51.03	-15.71
8	672.21	39.87 QP	47.00	-7.13	3.19 V	313	42.06	-2.19
9	1000.00	38.21 QP	47.00	-8.79	1.99 V	258	34.07	4.14

**Remarks:**

1. Emission Level(dBuV/m) = Raw Value(dBuV) + Correction Factor(dB/m)
2. Correction Factor(dB/m) = Antenna Factor (dB/m) + Cable Factor (dB) – Pre-Amplifier Factor (dB)
3. The other emission levels were very low against the limit.
4. Margin value = Emission level – Limit value



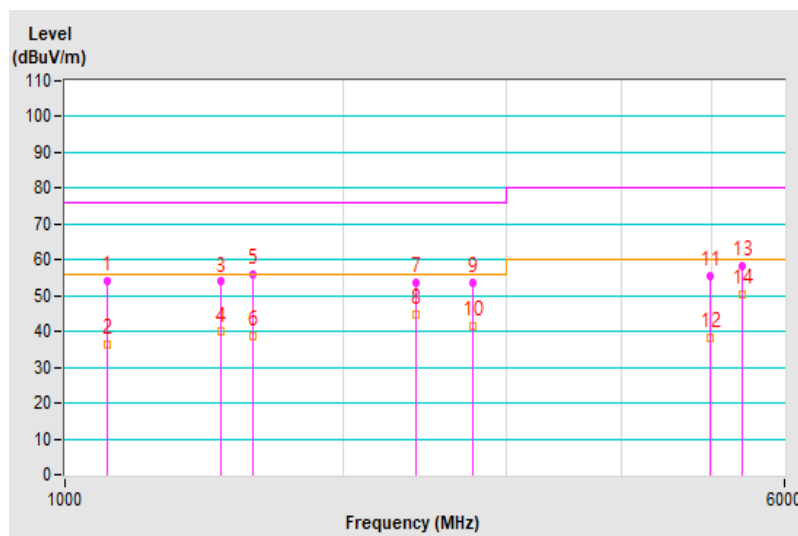
#### 7.4 Radiated Emissions above 1 GHz

Frequency Range	1GHz ~ 6GHz	Detector Function & Resolution Bandwidth	Peak (PK) / Average (AV), 1MHz
Tested By	Vincent Lin	Environmental Conditions	23.0°C, 67.0%RH, 1001mbar
Test Mode	Mode 2	Test Date	2021/5/18

Antenna Polarity & Test Distance : Horizontal at 3 m								
No	Frequency (MHz)	Emission Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Antenna Height (m)	Table Angle (Degree)	Raw Value (dBuV)	Correction Factor (dB/m)
1	1109.62	54.20 PK	76.00	-21.80	1.50 H	132	57.37	-3.17
2	1109.62	36.53 AV	56.00	-19.47	1.50 H	132	39.70	-3.17
3	1474.13	53.85 PK	76.00	-22.15	2.26 H	138	57.31	-3.46
4	1474.13	39.88 AV	56.00	-16.12	2.26 H	138	43.34	-3.46
5	1596.63	55.84 PK	76.00	-20.16	1.00 H	242	59.03	-3.19
6	1596.63	38.72 AV	56.00	-17.28	1.00 H	242	41.91	-3.19
7	2399.98	53.56 PK	76.00	-22.44	2.50 H	108	54.00	-0.44
8	2399.98	44.93 AV	56.00	-11.07	2.50 H	108	45.37	-0.44
9	2756.54	53.51 PK	76.00	-22.49	1.75 H	132	53.40	0.11
10	2756.54	41.45 AV	56.00	-14.55	1.75 H	132	41.34	0.11
11	4978.23	55.62 PK	80.00	-24.38	2.48 H	78	50.01	5.61
12	4978.23	38.31 AV	60.00	-21.69	2.48 H	78	32.70	5.61
13	5400.00	58.31 PK	80.00	-21.69	2.59 H	113	51.24	7.07
14	5400.00	50.39 AV	60.00	-9.61	2.59 H	113	43.32	7.07

#### Remarks:

1. Emission Level(dBuV/m) = Raw Value(dBuV) + Correction Factor(dB/m)
2. Correction Factor(dB/m) = Antenna Factor (dB/m) + Cable Factor (dB) – Pre-Amplifier Factor (dB)
3. The other emission levels were very low against the limit.
4. Margin value = Emission level – Limit value

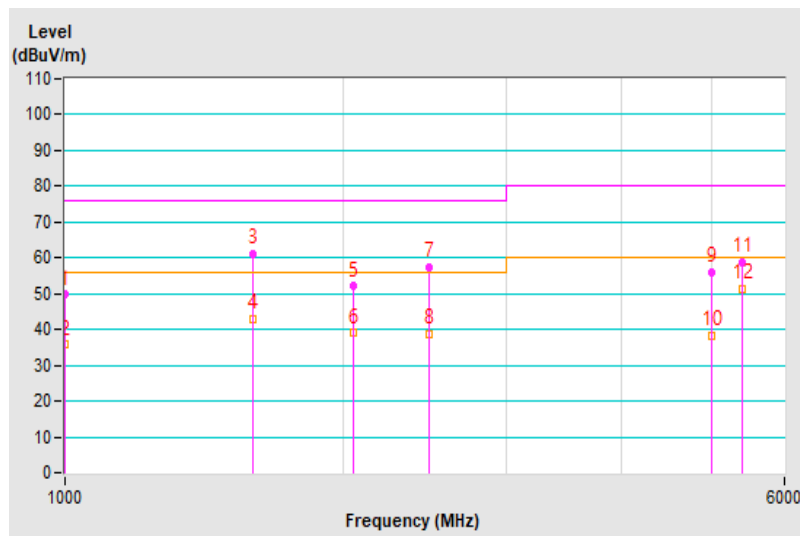


Frequency Range	1GHz ~ 6GHz	Detector Function & Resolution Bandwidth	Peak (PK) / Average (AV), 1MHz
Tested By	Vincent Lin	Environmental Conditions	23.0°C, 67.0%RH, 1001mbar
Test Mode	Mode 2	Test Date	2021/5/18

Antenna Polarity & Test Distance : Vertical at 3 m								
No	Frequency (MHz)	Emission Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Antenna Height (m)	Table Angle (Degree)	Raw Value (dBuV)	Correction Factor (dB/m)
1	1000.02	49.76 PK	76.00	-26.24	2.50 V	9	53.88	-4.12
2	1000.02	35.72 AV	56.00	-20.28	2.50 V	9	39.84	-4.12
3	1595.62	61.12 PK	76.00	-14.88	1.20 V	233	64.32	-3.20
4	1595.62	43.04 AV	56.00	-12.96	1.20 V	233	46.24	-3.20
5	2051.06	52.09 PK	76.00	-23.91	1.97 V	144	52.05	0.04
6	2051.06	39.02 AV	56.00	-16.98	1.97 V	144	38.98	0.04
7	2475.70	57.38 PK	76.00	-18.62	1.00 V	209	57.78	-0.40
8	2475.70	38.81 AV	56.00	-17.19	1.00 V	209	39.21	-0.40
9	4999.22	56.13 PK	80.00	-23.87	1.70 V	2	50.42	5.71
10	4999.22	38.15 AV	60.00	-21.85	1.70 V	2	32.44	5.71
11	5400.03	58.75 PK	80.00	-21.25	2.59 V	130	51.68	7.07
12	<b>5400.03</b>	<b>51.35 AV</b>	<b>60.00</b>	<b>-8.65</b>	<b>2.59 V</b>	<b>130</b>	<b>44.28</b>	<b>7.07</b>

Remarks:

1. Emission Level(dBuV/m) = Raw Value(dBuV) + Correction Factor(dB/m)
2. Correction Factor(dB/m) = Antenna Factor (dB/m) + Cable Factor (dB) – Pre-Amplifier Factor (dB)
3. The other emission levels were very low against the limit.
4. Margin value = Emission level – Limit value



## 7.5 Harmonic Current Measurement

Fundamental Voltage/Ampere	230.56Vrms/ 0.756Arms	Power Frequency	50.00Hz
Power Consumption	158.8W	Power Factor	0.942
Environmental Conditions	24°C, 80% RH	Tested by	Xun Lee
Test Mode	Mode 2	Test Date	2021/5/31

Harm #	Harms (avg) (A)	100% Limit (A)	Harms (max) (A)	150% Limit (A)	Test Result
3	0.065	0.540	0.066	0.810	Pass
5	0.022	0.302	0.023	0.453	Pass
7	0.020	0.159	0.020	0.238	Pass
9	0.016	0.079	0.016	0.119	Pass
11	0.014	0.056	0.014	0.083	Pass
13	0.012	0.048	0.012	0.071	Pass
15	0.008	0.041	0.009	0.062	Pass
17	0.006	0.037	0.007	0.055	Pass
19	0.004	0.032	0.005	0.048	Pass
21	0.007	0.029	0.009	0.044	Pass
23	0.009	0.027	0.011	0.040	Pass
25	0.005	0.024	0.006	0.037	Pass
27	0.006	0.023	0.008	0.034	Pass
29	0.004	0.021	0.005	0.032	Pass
31	0.003	0.020	0.004	0.030	Pass
33	0.003	0.018	0.004	0.028	Pass
35	0.004	0.017	0.004	0.026	Pass
37	0.004	0.017	0.004	0.025	Pass
39	0.003	0.016	0.003	0.024	Pass

Note: Dynamic limits were applied for this test. The highest harmonics values in the above table may not occur at the same window as the maximum harmonics/limit ratio.



## 7.6 Voltage Fluctuations and Flicker Measurement

Fundamental Voltage/Ampere	230.56Vrms/ 0.756Arms	Power Frequency	50.00Hz
Observation ( $T_p$ )	10 min.	Power Factor	0.942
Environmental Conditions	24°C, 80% RH	Tested by	Xun Lee
Test Mode	Mode 2	Test Date	2021/5/31

Test Duration	10 min		
Test Parameter	Measurement Value	Limit	Remark
$P_{st}$	0.319	1.0	Pass
$P_{lt}$	0.139	0.65	Pass
$T_{max}$ (ms)	0	500	Pass
$d_c$ (%)	0	3.3%	Pass
$d_{max}$ (%)	0	<input checked="" type="checkbox"/> 4% <input type="checkbox"/> 6% <input type="checkbox"/> 7%	Pass

- Note: (1)  $P_{st}$  means short-term flicker indicator.  
 (2)  $P_{lt}$  means long-term flicker indicator.  
 (3)  $T_{max}$  means accumulated time value of  $d(t)$  with a deviation exceeding 3.3 %.  
 (4)  $d_{max}$  means maximum relative voltage change.  
 (5)  $d_c$  means maximum relative steady-state voltage change.

### 7.7 Electrostatic Discharge (ESD)

Input Power	230Vac, 50 Hz	Tested by	Kent Wang
Environmental Conditions	23°C, 47% RH 1002 mbar	Test Date	2021/6/2
Test mode	Mode 2		

Test Results of Direct Application					
Discharge Level (kV)	Polarity (+/-)	Test Point	Contact Discharge	Air Discharge	Performance Criteria
2, 4	+/-	1-3, 11	Note 1	NA	A
2, 4, 8	+/-	4-7, 12, 13	NA	Note 1	A
2, 4	+/-	8-10	NA	Note 1	A
8	+/-	8-10	NA	Note 2, 3	B

Description of test points of direct application: Please refer to following page for representative mark only.

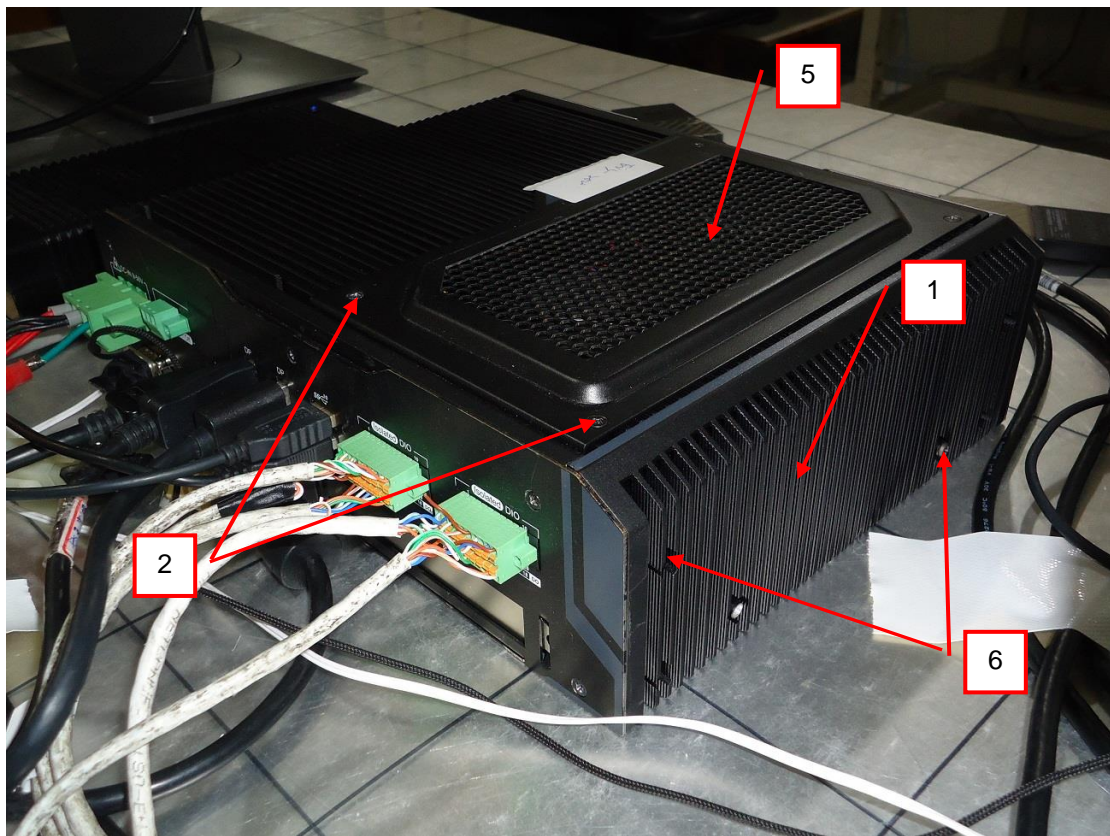
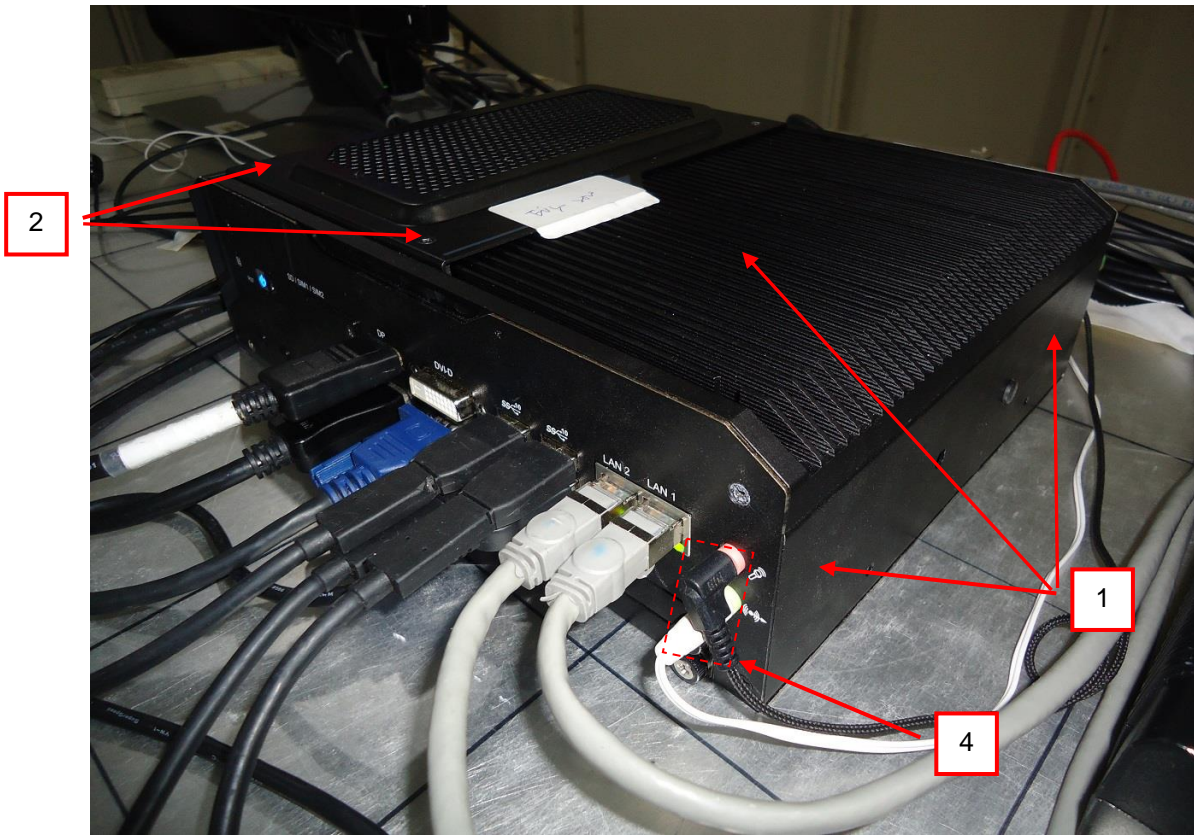
Test Results of Indirect Application					
Discharge Level (kV)	Polarity (+/-)	Test Point	Horizontal Coupling Plane	Vertical Coupling Plane	Performance Criteria
2, 4	+/-	Four Sides	Note 1	Note 1	A

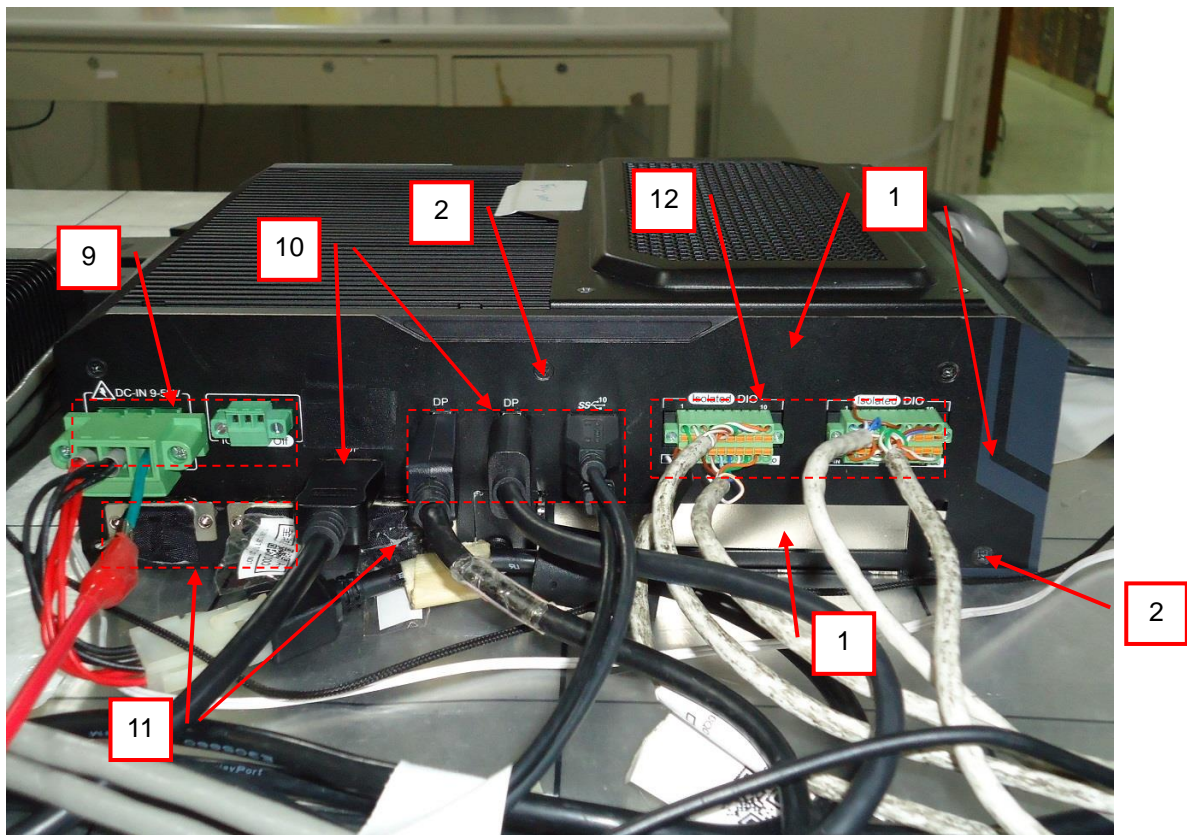
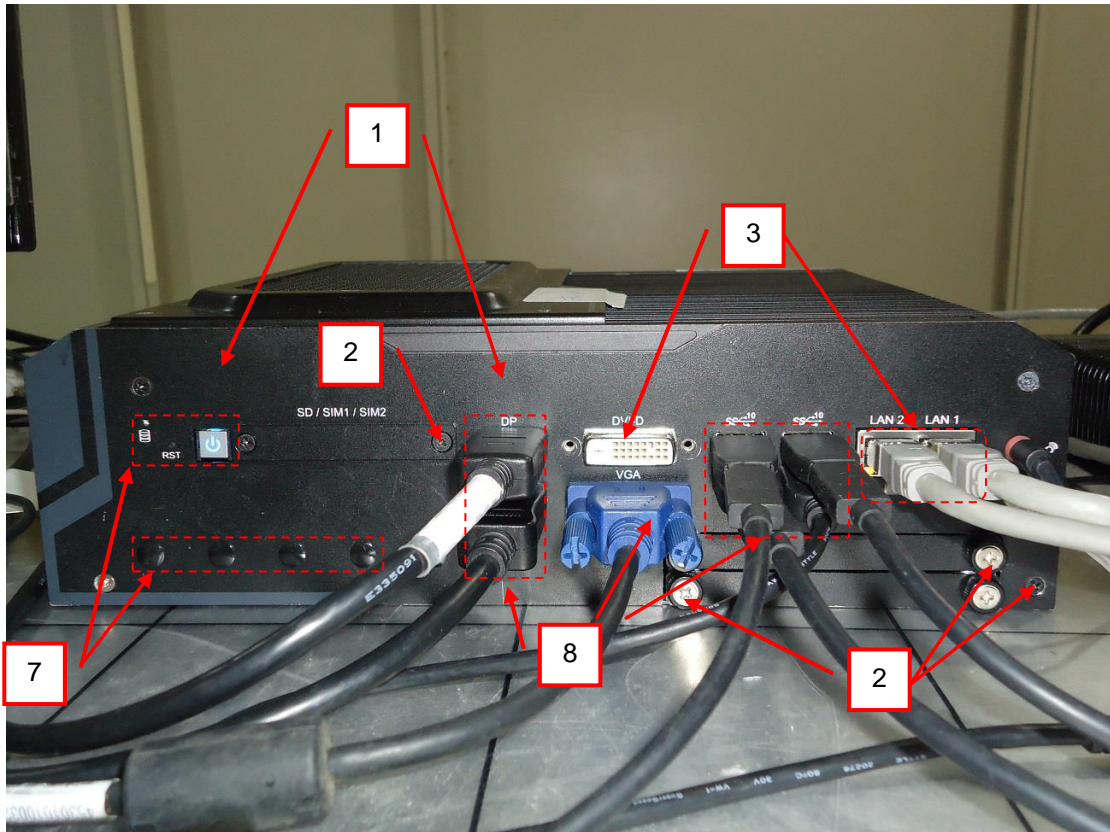
Description of test points of indirect application:

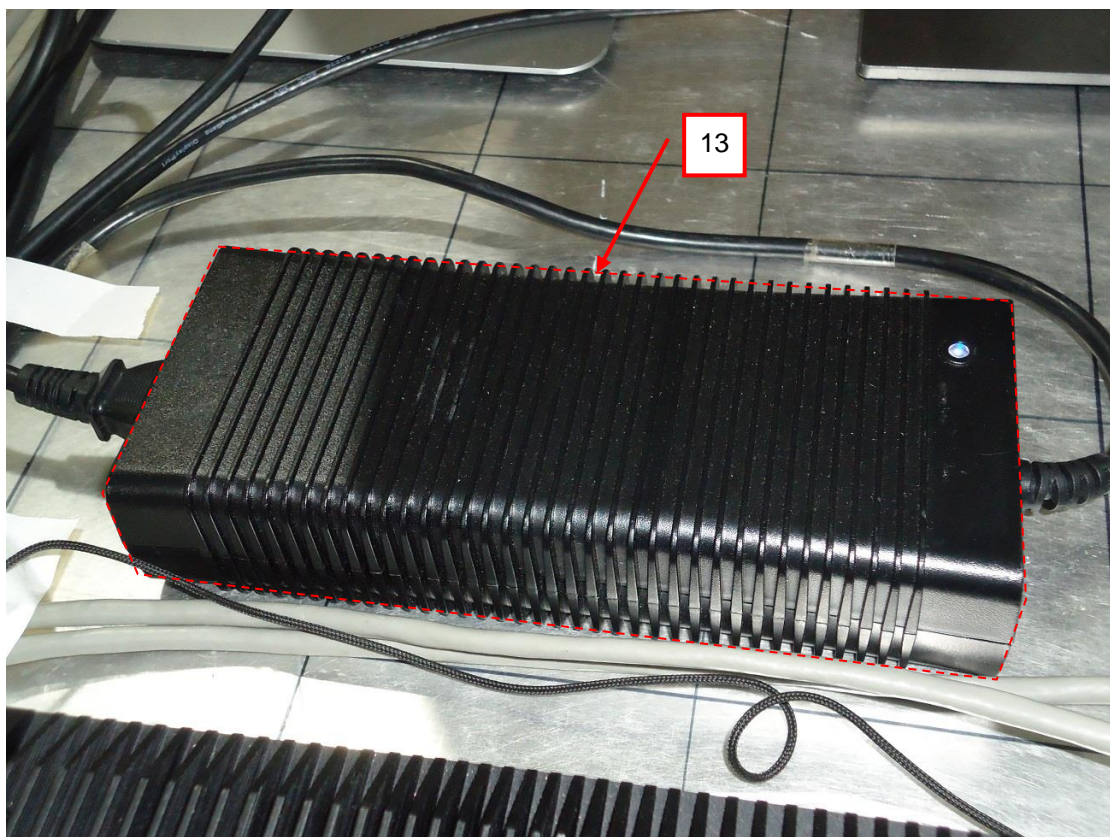
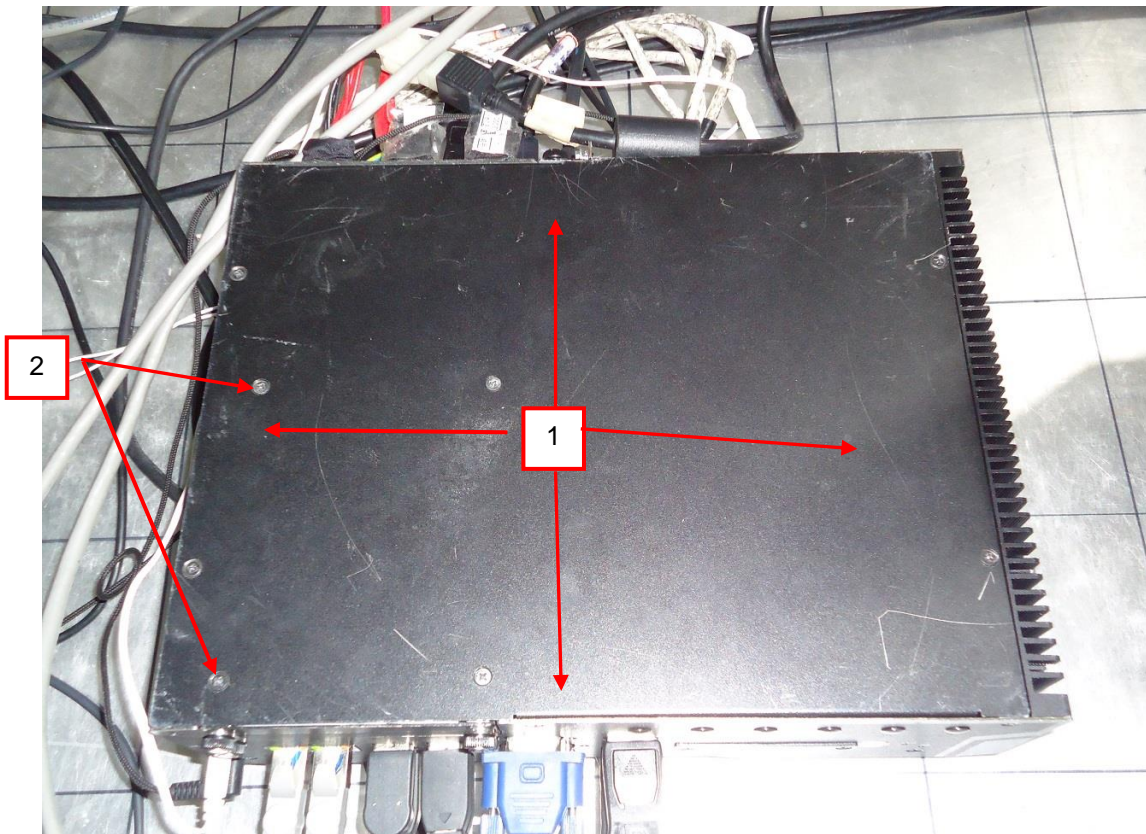
1. Front side                      2. Rear side                      3. Right side                      4. Left side

- Note: 1. The EUT function was correct during the test.  
 2. The image on the screen disappeared during the test, but could self-recover after the test.  
 3. R/W function was delayed 1-2 seconds during the test, but could self-recover after the test.

### DESCRIPTION OF TEST POINT







### 7.8 Radio Frequency Electromagnetic Field (RS)

Input Power	230Vac, 50 Hz	Tested by	Xun Lee
Environmental Conditions	22°C, 70% RH	Test Date	2021/5/31
Test mode	Mode 2		

Frequency (MHz)	Polarity	Azimuth(°)	Applied Field Strength		Test Distance (m)	Observation	Performance Criteria
			(V/m)	Modulation			
80 -1000	V&H	0	3	80% AM (1kHz)	3	Note	A
		90	3	80% AM (1kHz)	3	Note	A
		180	3	80% AM (1kHz)	3	Note	A
		270	3	80% AM (1kHz)	3	Note	A
1800, 2600, 3500, 5000	V&H	0	3	80% AM (1kHz)	3	Note	A
		90	3	80% AM (1kHz)	3	Note	A
		180	3	80% AM (1kHz)	3	Note	A
		270	3	80% AM (1kHz)		Note	A

Note: The EUT function was correct during the test.

### 7.9 Fast Transients Common Mode (EFT)

Input Power	230Vac, 50 Hz	Tested by	Xun Lee
Environmental Conditions	22°C, 70% RH	Test Date	2021/5/26
Test mode	Mode 2		

Input AC power port

Voltage (kV)	Test Point	Polarity (+/-)	Observation	Performance Criteria
1	L1	+/-	Note	A
1	L2	+/-	Note	A
1	PE	+/-	Note	A
1	L1-L2-PE	+/-	Note	A

Wired network and signal/ control port

Voltage (kV)	Test Point	Polarity (+/-)	Observation	Performance Criteria
0.5	LAN (port 1, 2)	+/-	Note	A

Note: The EUT is operated normal during the test.

### 7.10 Surge

Input Power	230Vac, 50 Hz	Tested by	Xun Lee
Environmental Conditions	22°C, 70% RH	Test Date	2021/6/1
Test mode	Mode 2		

#### Input AC power port

Voltage (kV)	Test Point	Polarity (+/-)	Observation	Performance Criteria
0.5, 1	L1-L2	+/-	Note	A
0.5, 1, 2	L1-PE	+/-	Note	A
0.5, 1, 2	L2-PE	+/-	Note	A

Note: The EUT function was correct during the test.

### 7.11 Radio Frequency Common Mode (CS)

Input Power	230Vac, 50 Hz	Tested by	Xun Lee
Environmental Conditions	22°C, 70% RH	Test Date	2021/6/1
Test mode	Mode 2		

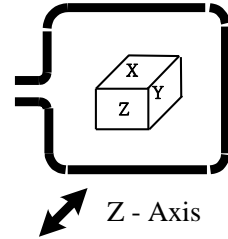
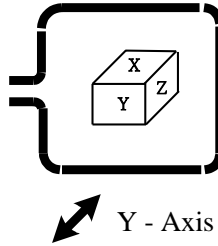
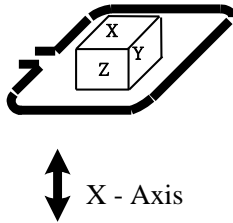
#### Input AC power port

Frequency (MHz)	Level (Vrms)	Tested Line	Injection Method	Return Path	Observation	Performance Criteria
0.15 – 10	3	AC Power	CDN-M3	CDN-M1	Note	A
10 – 30	3 – 1	AC Power	CDN-M3	CDN-M1	Note	A
30 – 80	1	AC Power	CDN-M3	CDN-M1	Note	A
0.15 – 10	3	LAN (port 1, 2)	CDN-ST08A	CDN-M1	Note	A
10 – 30	3 – 1	LAN (port 1, 2)	CDN-ST08A	CDN-M1	Note	A
30 – 80	1	LAN (port 1, 2)	CDN-ST08A	CDN-M1	Note	A

Note: The EUT function was correct during the test.

### 7.12 Power Frequency Magnetic Field (PFMF)

Input Power	230Vac, 50 Hz	Tested by	Xun Lee
Environmental Conditions	22°C, 70% RH	Test Date	2021/6/1
Test mode	Mode 2		



Application	Frequency (Hz)	Field Strength (A/m)	Observation	Performance Criteria
X - Axis	50	1	Note	A
Y - Axis	50	1	Note	A
Z - Axis	50	1	Note	A

Note: The EUT function was correct during the test.



### 7.13 Voltage Dips and Interruptions (DIP)

Input Power	230Vac, 50 Hz; 240Vac, 50 Hz; 100Vac, 50 Hz	Tested by	Xun Lee
Environmental Conditions	22°C, 70% RH	Test Date	2021/5/31
Test mode	Mode 2		

Input Power for testing: 230Vac, 50 Hz (Nominal input Voltage)					
Voltage Residual (%)	Duration (cycle)	Interval (sec)	Times	Observation	Performance Criteria
< 5	0.5	10	3	Note 1	A
70	25	10	3	Note 1	A
< 5	250	10	3	Note 2	C

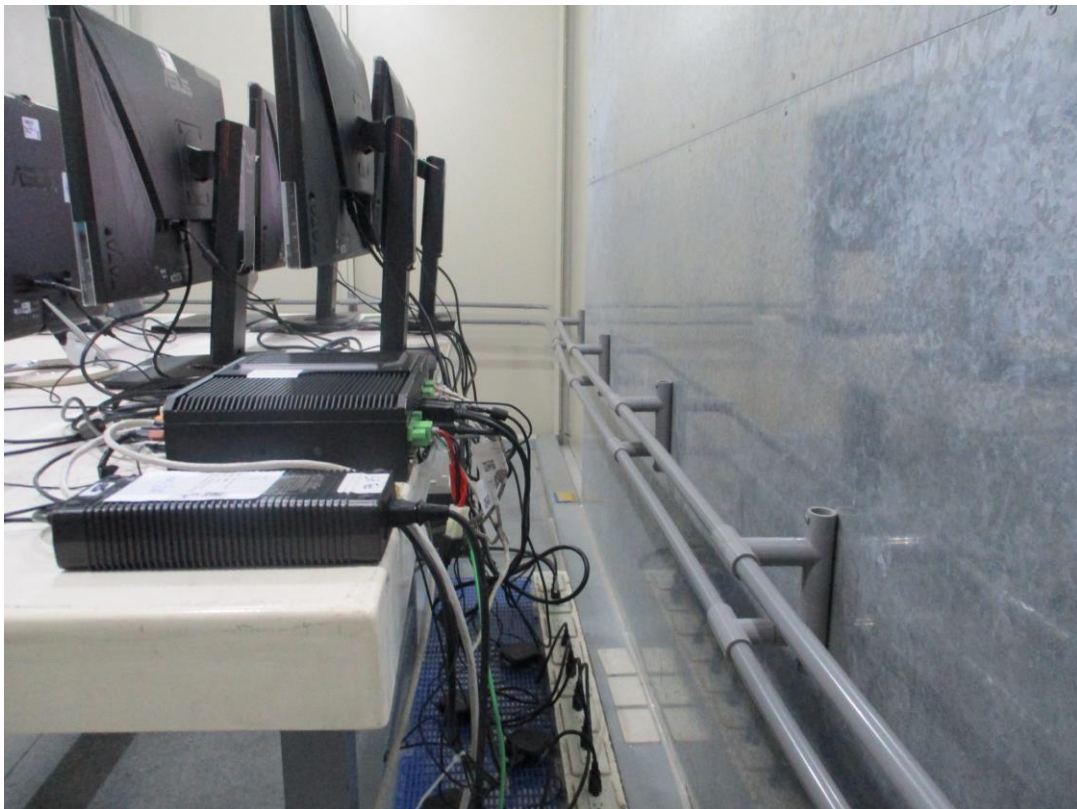
Input Power for testing: 240Vac, 50 Hz (Maximum rated input voltage)					
Voltage Residual (%)	Duration (cycle)	Interval (sec)	Times	Observation	Performance Criteria
< 5	0.5	10	3	Note 1	A
70	25	10	3	Note 1	A
< 5	250	10	3	Note 2	C

Input Power for testing: 100Vac, 50 Hz (Minimum rated input voltage)					
Voltage Residual (%)	Duration (cycle)	Interval (sec)	Times	Observation	Performance Criteria
< 5	0.5	10	3	Note 1	A
70	25	10	3	Note 1	A
< 5	250	10	3	Note 2	C

- Note: 1. The EUT is operated normal during the test.  
 2. The EUT shut down but could be restored by the operator.

## 8 Pictures of Test Arrangements

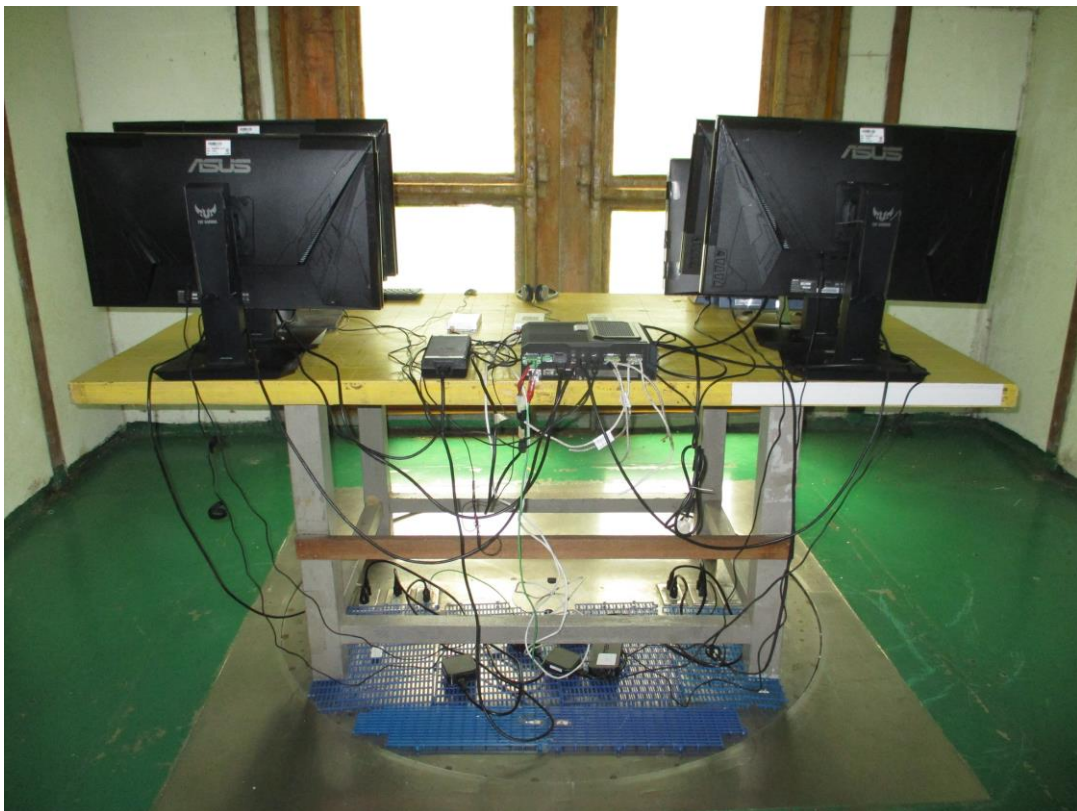
### 8.1 Conducted Emissions from Power Ports



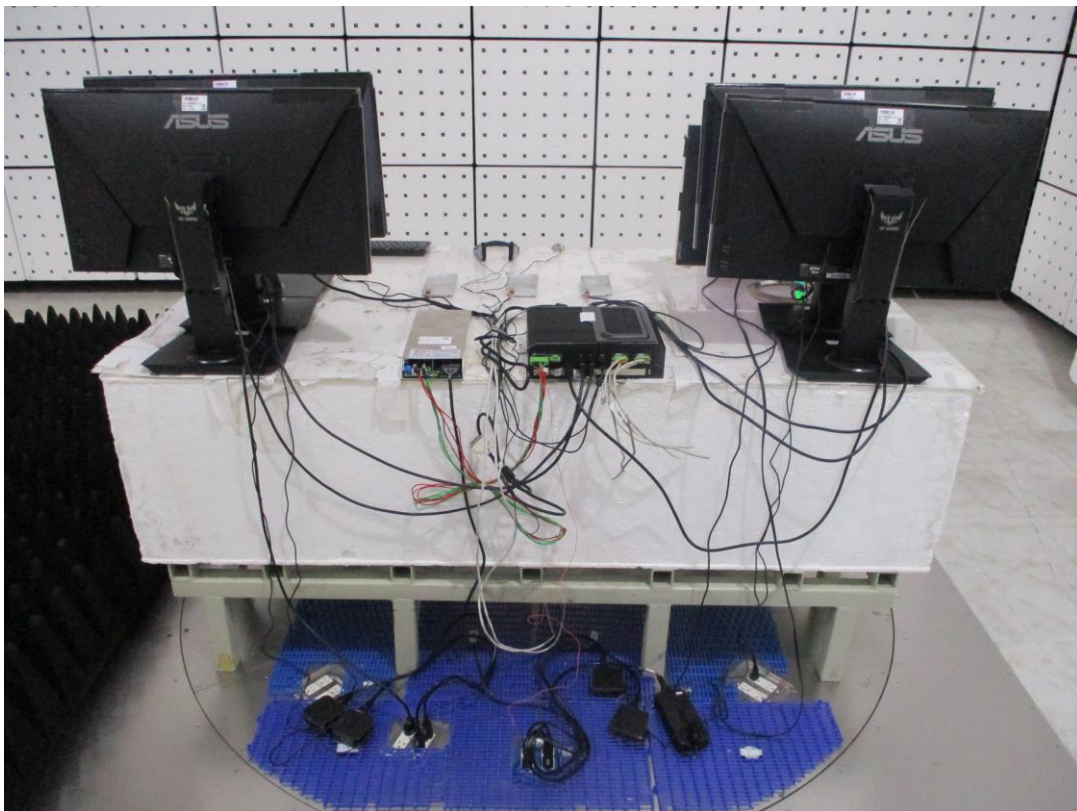
## 8.2 Conducted Emissions from Wired Network Ports



### 8.3 Radiated Emissions up to 1 GHz



#### 8.4 Radiated Emissions above 1 GHz



## 8.5 Harmonic Current Measurement



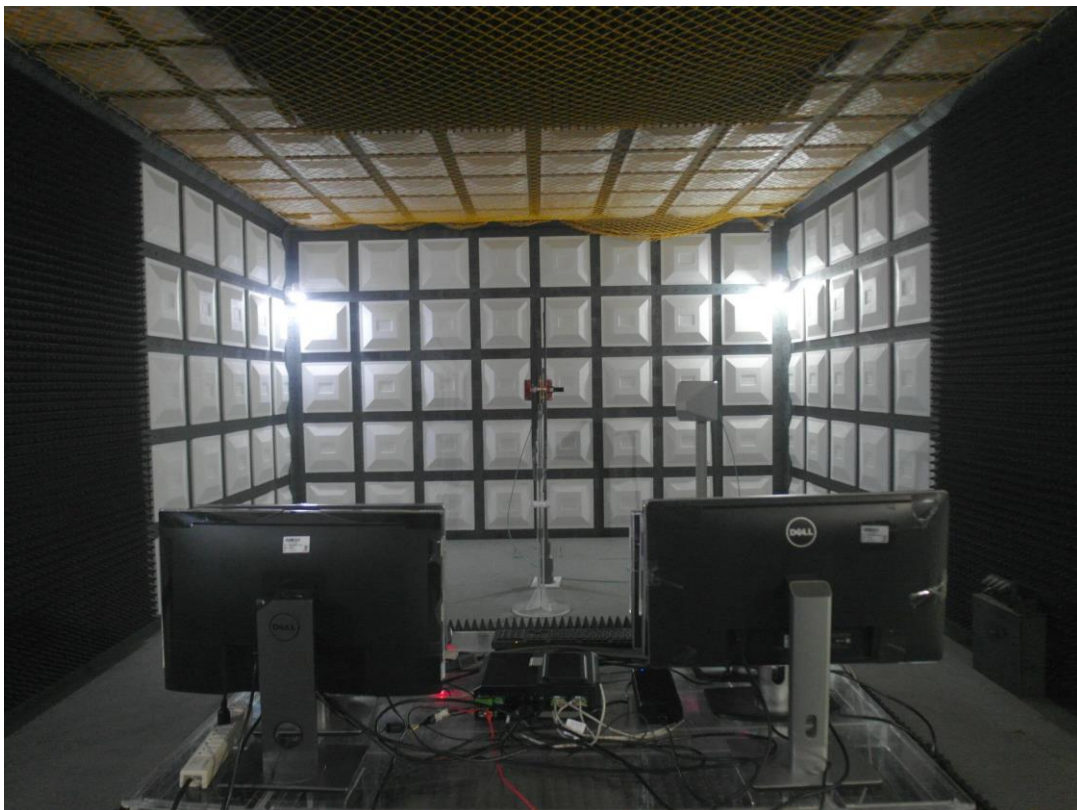
## 8.6 Voltage Fluctuations and Flicker Measurement



## 8.7 Electrostatic Discharge (ESD)



## 8.8 Radio Frequency Electromagnetic Field (RS)





## 8.9 Fast Transients Common Mode (EFT)

Mains port



LAN port



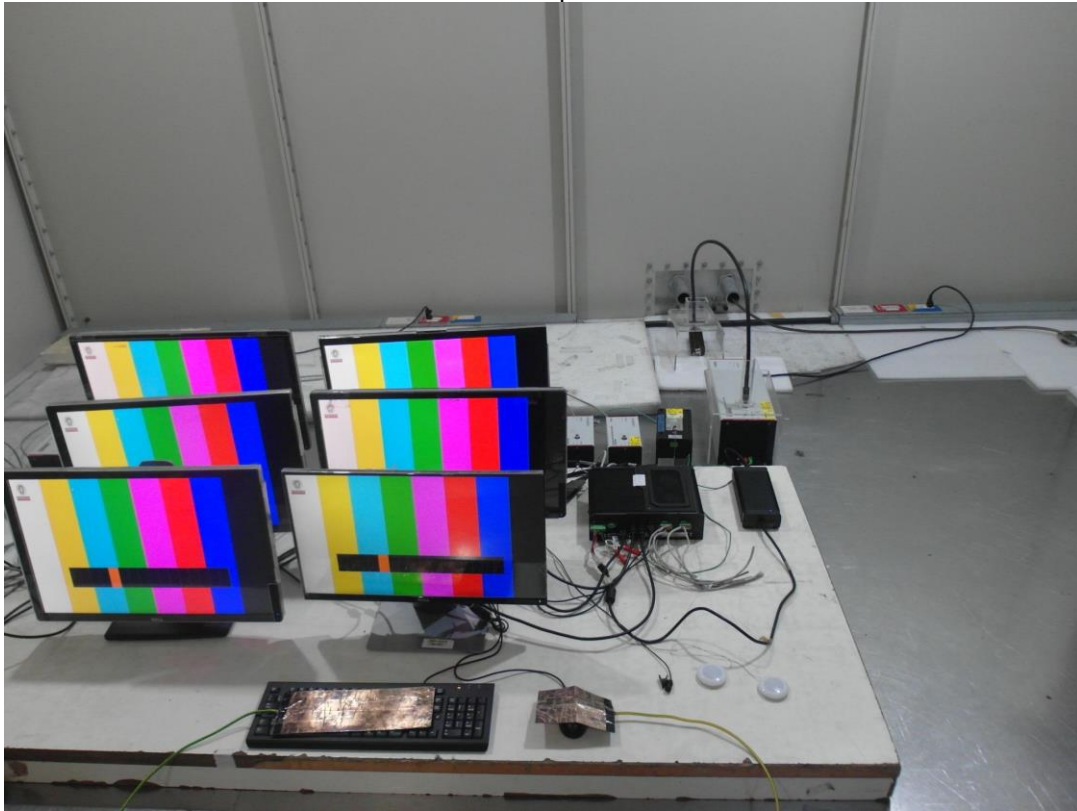
## 8.10 Surge

Mains port

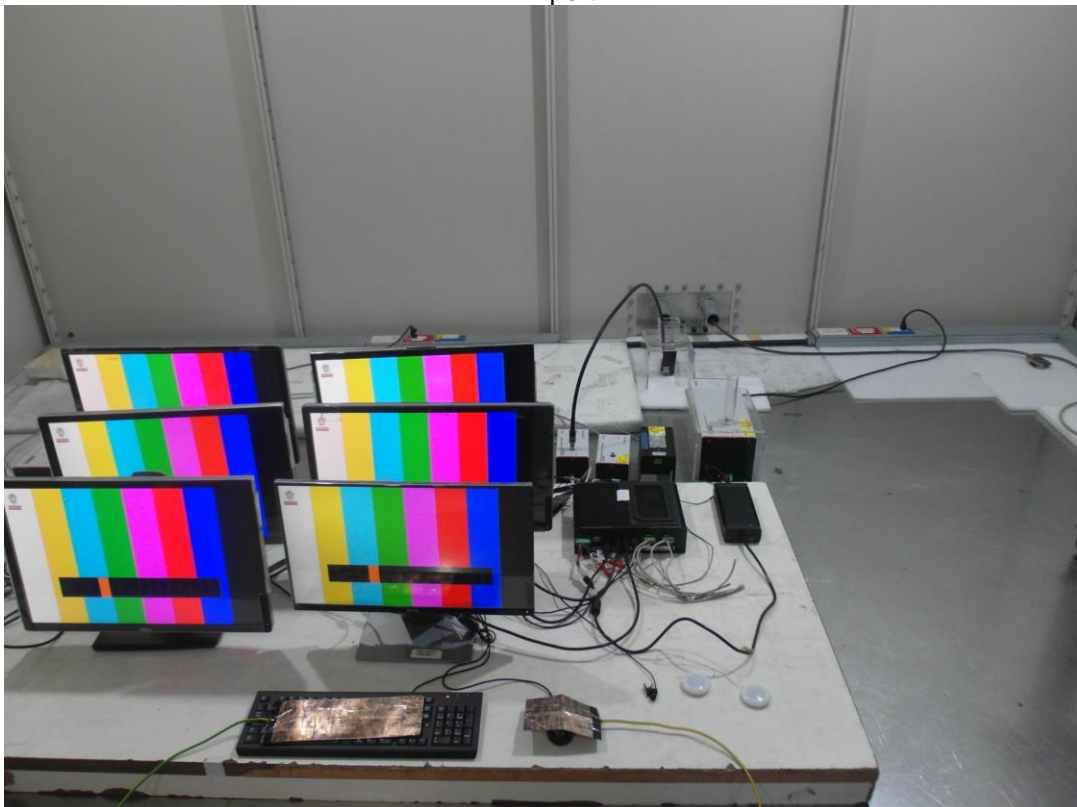


## 8.11 Radio Frequency Common Mode (CS)

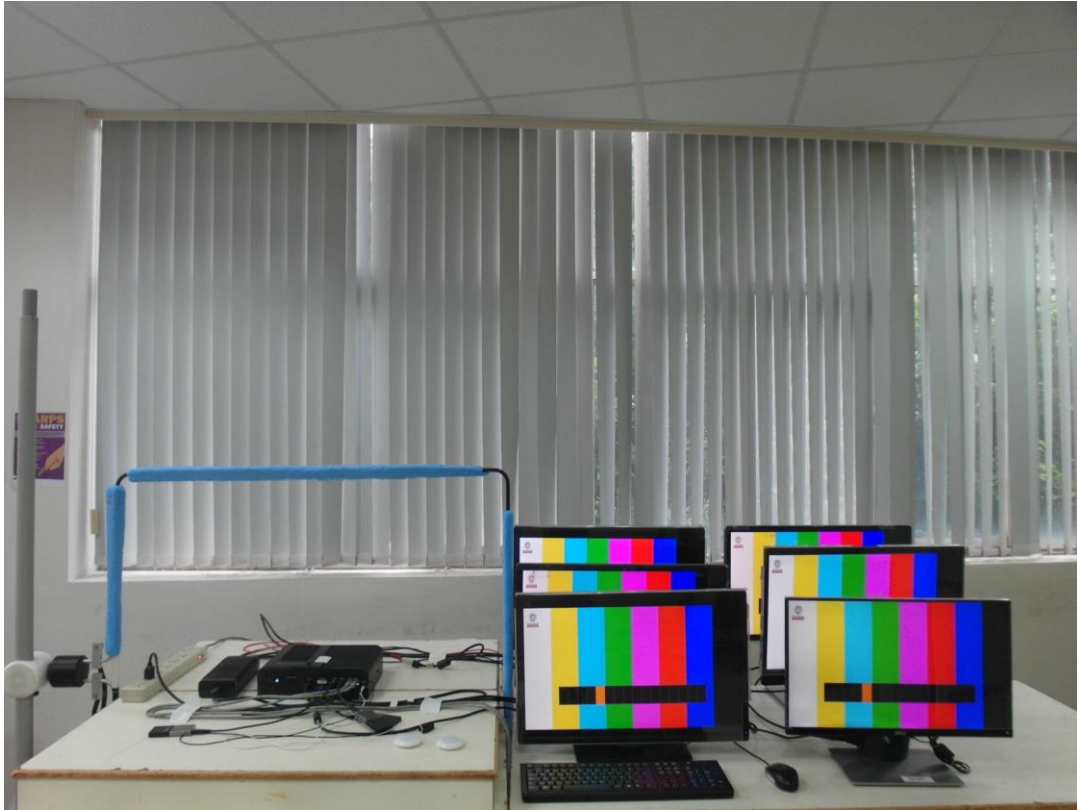
Mains port



LAN port



### 8.12 Power-frequency magnetic fields (PFMF)



### 8.13 Voltage Dips and Interruptions (DIP)



## 9 Information of the Testing Laboratories

We, Bureau Veritas Consumer Products Services (H.K.) Ltd., Taoyuan Branch, were founded in 1988 to provide our best service in EMC, Radio, Telecom and Safety consultation. Our laboratories are accredited and approved according to ISO/IEC 17025.

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The address and road map of all our labs can be found in our web site also.

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